

THE SERIAL DATA SUPERPOWER



Exceptional Signal Characterization Performance

Unrivaled Validation and Debug Capabilities

Built-in Serial Data Expertise

WaveMaster 8000HD

6 GHz - 65 GHz

12-bit High Definition Oscilloscopes

Exceptional Signal Characterization Performance

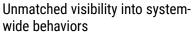
The most powerful signal acquisition and processing platform available

- Up to 65 GHz bandwidth at 320 GS/s
- 12-bit resolution at full bandwidth and sample rate
- Fast processing of long waveforms

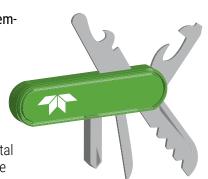




Unrivaled Validation and Debug Capabilities



- *Cross*Sync™ PHY protocol analyzer synchronization
- The industry's longest acquisition memory
- Serial triggers, built-in digital inputs and high-impedance (1 MΩ) probe support

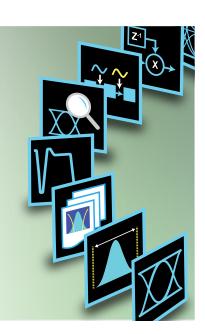




Built-in Serial Data Expertise

Simple and powerful analysis tools for serial data

- Tailored signal analysis for PCI Express[®], USB-C[®], DDR, and other technologies
- Powerful PAM and NRZ eye diagram, jitter and link analysis tools
- Simple automation of complex compliance testing





The Serial Data Superpower



WaveMaster 8000HD

TOTAL DEVELOPMENT CYCLE COVERAGE



Characterization

Understanding device performance requires a unique combination of high signal fidelity and advanced analysis capability.

WaveMaster 8000HD's 12-bit resolution at up to 65 GHz bandwidth means pristine signal quality for high-speed signals.

SDA Expert eye, jitter and noise measurement for PAM and NRZ signals, coupled with a highperformance PC system, makes complex analysis easy and fast.



Automation

WaveMaster 8000HD offers powerful, flexible test automation tools and capabilities to improve workflow and minimize setup errors.

QualiPHY® automated test options improve repeatability and reduce test times for more efficient high-volume testing.

The best-in-class PC platform completes complex analysis processing tasks faster, resulting in better test throughput.



Compliance

Today's technologies impose strict requirements for characterization and compliance testing. WaveMaster 8000HD simplifies these workflows with QualiPHY test automation options for PCIe®, USB, DDR and more.

SDA Expert eye diagram, jitter and noise analysis with technology-specific measurement tools complements the compliance packages for deeper insight.

When test setups need troubleshooting, WaveMaster 8000HD's unique set of debug tools helps to quickly get back to making measurements.

TOTAL DEVELOPMENT CYCLE COVERAGE



Validation

Going beyond compliance means ensuring the device works as intended in all conditions.

WaveMaster 8000HD's 8 Gpts of memory on all four channels - the most of any oscilloscope - captures intermittent or one-off events which may only occur over long timespans.

Differential probes with up to 30 GHz bandwidth enable visibility into signals anywhere in the system under test.

Unique mixed-signal inputs capture and trigger on sideband signals without using up valuable analog inputs.

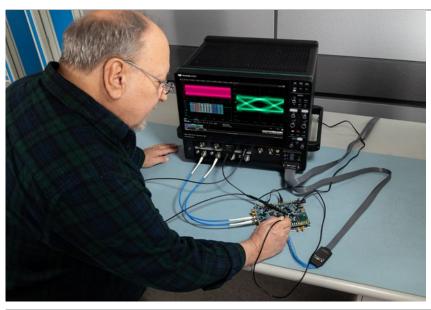


Integration

One of the most challenging problems in the development cycle occurs when two otherwise-compliant devices fail to interoperate correctly. The WaveMaster 8000HD was designed for this particular debug scenario.

CrossSync PHY software integration with Teledyne LeCroy protocol analyzers shows the entire protocol stack at once, while compatible interposers and test coupon fixtures simplify signal access in complex systems.

WaveMaster 8000HD's flexible inputs enable capturing all critical device signals: high-speed lines, power rails, digital sidebands and more.



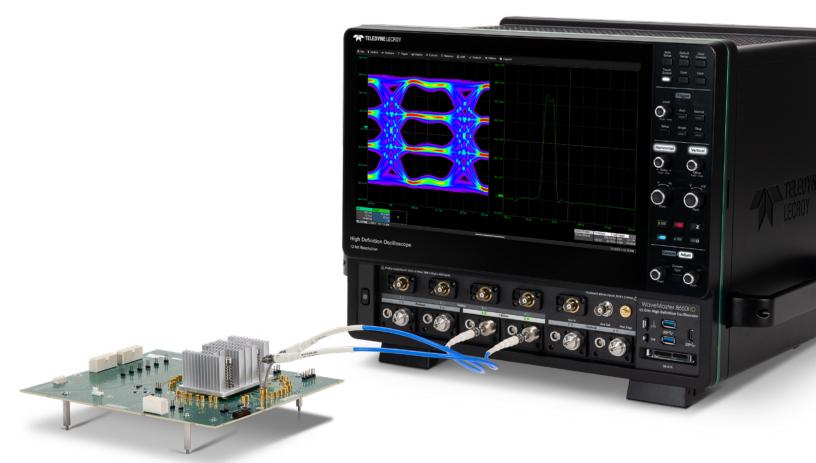
Debug

Debugging high-speed interfaces used to mean having two oscilloscopes on hand: one for high-speed characterization and one for embedded debug. WaveMaster 8000HD does it all, without compromise.

It has flexible inputs for capturing all critical device signals, using passive probes and current probes alongside high-speed analog inputs and digital signals.

Plus, WaveMaster 8000HD's industry-leading 8 Gpts acquisition memory option enables up to 100 ms capture time at full bandwidth.

PERFORMANCE



Modern serial data technologies require an oscilloscope with class-leading performance in more ways than ever. Faster signals are driving higher bandwidth requirements. New trends towards higher-order modulations like PAM3 and PAM4 mean that oscilloscope resolution is now a critical consideration. Complex analysis methodologies demand more computing power.

Up to 65 GHz at 320 GS/s

WaveMaster 8000HD has the bandwidth to acquire, visualize and characterize even the fastest serial data signals.

Proven Digital Bandwidth Interleaving (DBI) technology seamlessly creates a pristine 65 GHz signal path.

12-bit Resolution

WaveMaster 8000HD provides 12-bit resolution all the time, at all sample rates. Its combination of vertical resolution and visibility into high-frequency effects enables it to capture every signal detail.

Fast Waveform Processing

Modern serial data technologies mandate measurement methodologies that can be computationally demanding. WaveMaster 8000HD includes a classleading PC system, so less time is spent waiting for measurements to complete.

WAVEMASTER 8000HD AT A GLANCE







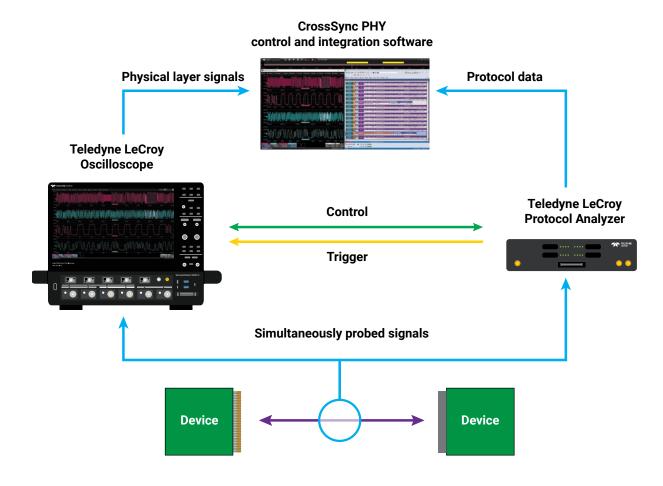


Key Attributes

- 1. 1.85 mm inputs (50 to 65 GHz bandwidth channels)
- **2a.** ProAxial inputs (25 to 33 GHz bandwidth channels)
- **2b.** ProLink inputs (6 to 20 GHz bandwidth channels)
- 3. ProBus inputs up to 2 GHz bandwidth (50 Ω) and 500 MHz bandwidth (1 M Ω)
- 4. Mixed-signal input 2.5 GS/s

- 5. Up to 8 Gpts acquisition memory
- 6. 15.6" 1920 x 1080 Full HD capacitive touchscreen
- MAUI[®] with OneTouch user interface for intuitive and efficient operation
- 8. Waveform control knobs
- 9. Color-coded panel indicators
- 10. Cursor/Adjust knobs

- 11. High-speed USB connectors
- 12. PC system with 64 GB RAM
- **13.** HDMI® and DisplayPort™ connectors with 4k resolution
- 14. Removable solid-state hard drive
- **13.** LBUS connector for HDA125 high-speed digital acquisition system
- 16. Reference Clock input/output
- 17. USBTMC over USB 3.1



Interoperability issues can lead to finger-pointing exercises that cost money and delay time-to-market.

CrossSync PHY technology merges the functions of a Teledyne LeCroy oscilloscope with a PCI Express or USB protocol analyzer for insight into link behavior that no other instrument can provide.

Validate and debug active link operation

- CrossSync PHY capable interposers and test coupon fixtures enable observation of both electrical and protocol behavior without disturbing the link
- Sideband signals, reference clock and power rails are all easily accessible to oscilloscope probes
- High-bandwidth oscilloscope probing points provide easy access to high-speed data lanes

Quickly resolve interoperability issues by capturing the entire protocol stack

- Trigger protocol analyzer and oscilloscope captures on the same high-level event
- Easily measure timing relationships between protocol and electrical domains
- Faster root-cause analysis means fewer costly finger-pointing exercises

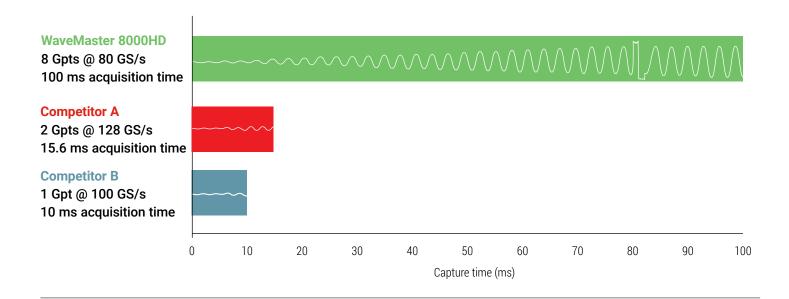
Analyze link training with integrated physical and protocol views

- Observe electrical-level results of protocol-level commands
- Combined navigation means always knowing which protocol and electrical behaviors happen at the same time
- No single instrument can deliver this level of cross-layer insight into link training behavior

UNRIVALED DEBUG CAPABILITIES

The Longest Oscilloscope Acquisition Memory

Long memory and high sample rates capture both millisecond-scale trends and picosecond-scale glitches. With up to 8 Gpts of acquisition memory, WaveMaster 8000HD captures events occurring over long periods of time, while maintaining high sample rate for visibility into the smallest details, and always at 12 bits of resolution. Oscilloscopes with less memory require trading off sample rate for acquisition time.



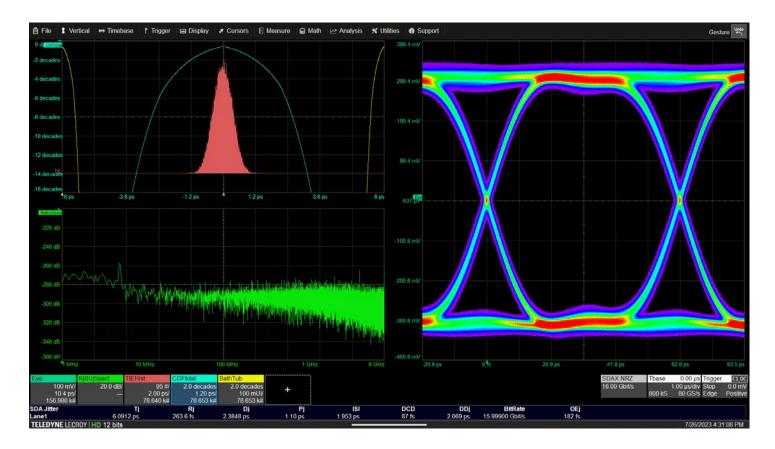
Comprehensive Embedded Debug Toolset

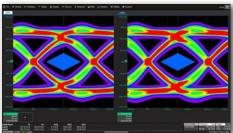
Debugging high-speed interfaces used to mean having two oscilloscopes on your bench – one high bandwidth oscilloscope and one general-purpose oscilloscope. WaveMaster 8000HD oscilloscopes do it all, without compromise.



SIMPLIFIED SERIAL DATA EXPERTISE

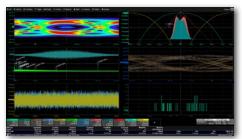
SDA Expert serial data analysis software is the first eye diagram and jitter analysis package with builtin technology expertise. It simplifies set up and expands debugging capabilities with tailored technology analysis for PCI Express, USB, DisplayPort and more.





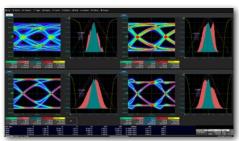


- Technology-specific measurement expertise is built in
- Seamlessly transition from compliance to debug
- Intuitive measurement selection saves time and avoids errors



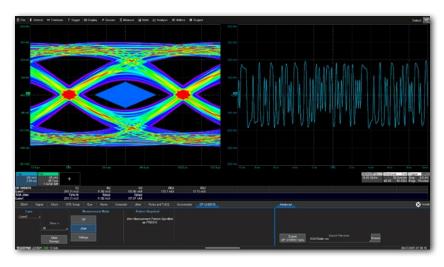
Most Complete Serial Data Analysis Toolbox

- Fourth-generation toolset covers everything needed for NRZ and PAM signals
- Integrates everything jitter, noise, crosstalk, equalization and pulse response
- Unique multi-view support with reference and comparison modes



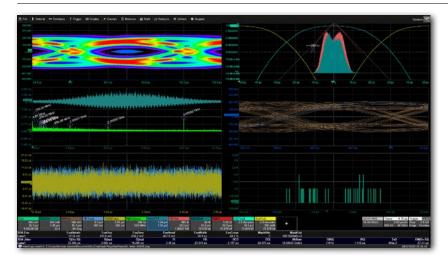
Highest Confidence for Complex Measurements

- One button set up saves time and avoids errors
- Technology selections simplify the set up of complex measurements
- Quickly document results and save data with built-in report generator



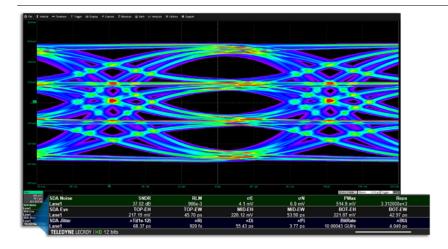
Technology-specific Analysis

- Predefined technology framework with added options simplifies measurement set up
- Dynamic graphical visualization of channel and test point setup
- Pre-defined test points simplify setup and avoid errors
- Easily make measurements exactly as defined in the technology standards



NRZ Analysis

- Comprehensive jitter decomposition, eye diagram and analysis capabilities
- Advanced signal integrity tools for embedding, de-embedding and equalization emulation
- Integrates jitter, noise, crosstalk, equalization and pulse response in one workflow
- Comprehensive jitter decomposition and analysis

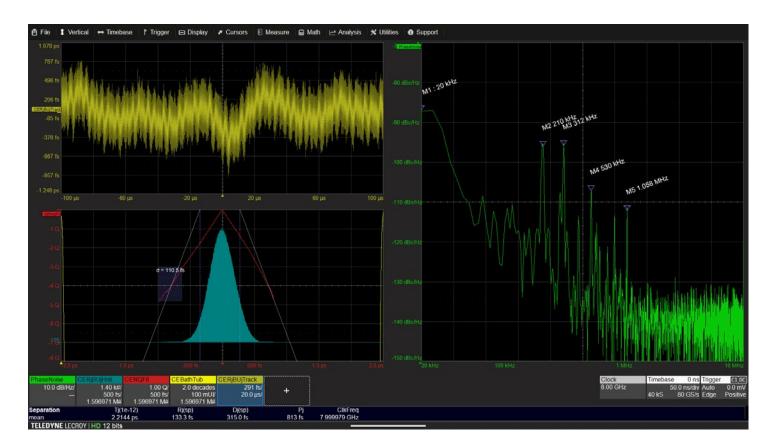


PAM Analysis

- Comprehensive PAM3 and PAM4 eye diagram, jitter and noise measurements
- Analysis of random, deterministic and periodic impairments for each eye opening
- Most complete SNDR and RLM analysis
- Powerful visualization tools for identifying unexpected noise and distortion components
- Comprehensive jitter and noise breakdown capability

MEASURE & ELIMINATE CLOCK JITTER IN DIGITAL CIRCUITS

Teledyne LeCroy's Clock Expert software, used with a compatible Teledyne LeCroy oscilloscope, is the most precise and sophisticated tool for measuring clock jitter, phase noise, and accumulated jitter, including very low frequency (<5 Hz) jitter.







Highest Precision Clock Signal Captures

- 12 bits resolution all-the-time ensures high precision measurements
- Long capture times measure very low frequency jitter
- High quality oscilloscope sample clock for low additive jitter

Improve Measurement Accuracy with Unique Noise Reduction Tools

- Heterodyne signal mixing reduces noise on low slew-rate clock signals
- Dual-input method provides additional noise reduction
- Flexible input bandwidth filtering further optimizes SNR of clock signal

Most Versatile and Efficient Clock Jitter Measurement Toolset

- Most consistent measurements
- Faster and more efficient analysis
- Most complete toolset



Measure and Eliminate Clock Jitter in Digital Circuits

In-circuit clock signals need to be highly accurate and stable to ensure proper circuit operation. Clock jitter, phase noise and other distortions must be understood and minimized to ensure the circuit operates at its maximum potential. Common measurements made using oscilloscopes include:

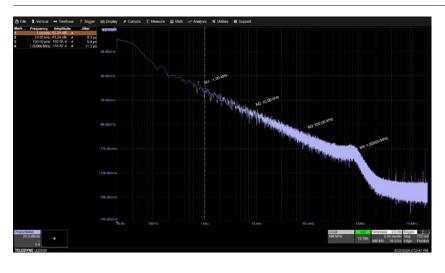
- Clock jitter, n-cycle jitter, accumulated jitter
- Phase noise measurements, phase noise to jitter correlation
- Spread spectrum clocking analysis
- Low-frequency jitter and wander measurements



Most Consistent Clock Jitter Measurements

Use Teledyne LeCroy's long oscilloscope memory to take one long clock signal acquisition and make all clock jitter measurements and phase noise analysis on the same set of data, using a single, consistent setup.

- Comprehensive jitter decomposition, eye diagram and analysis capabilities
- Advanced signal integrity tools for embedding, de-embedding and equalization emulation
- Integrates jitter, noise, crosstalk, equalization and pulse response in one workflow
- Comprehensive jitter decomposition and analysis



Most Complete Clock Jitter and Phase Noise Measurement Toolset

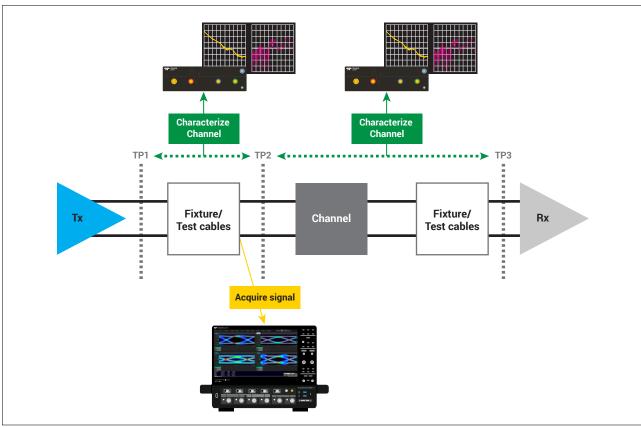
Expand jitter view to frequency domain using Phase Noise Analysis

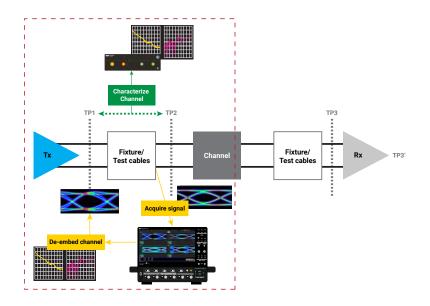
- Ultra long memory support for lowest phase noise frequency
- RMS phase noise jitter calculation
- Multi-cursor and table view

ANALYZE THE WHOLE LINK

Combining the WavePulser® 40iX High-speed Interconnect Analyzer, WaveMaster 8000HD oscilloscope and SDA Expert options gives the most complete signal integrity analysis toolkit available. Quickly characterize the entire signal path from transmitter to receiver, acquire high-fidelity waveforms at a convenient test point, then easily analyze the signal at any point of interest.

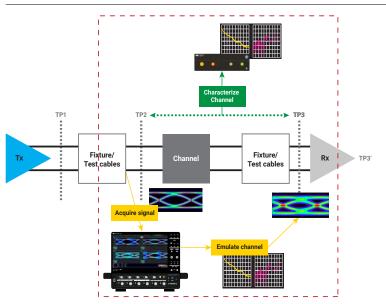






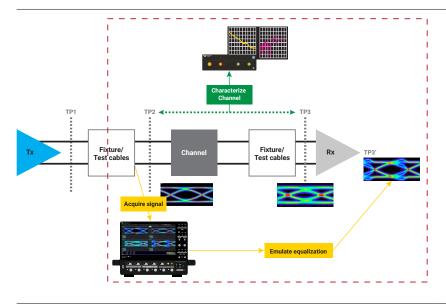
De-embed Fixtures and Test Cables

- Measure S-parameter models using WavePulser 40iX, or import from other files or simulation tools
- Sophisticated Eye Doctor and VirtualProbe tools easily and accurately remove the effects of fixtures and cables from acquired oscilloscope waveforms
- Apply the full SDA Expert Complete toolkit to de-embedded waveforms for full eye, jitter and noise analysis directly at the output pins of the device under test



Emulate Real-world Channel Losses

- WavePulser 40iX simplifies and speeds up accurate measurements of test channel loss profiles
- Channel model s-parameter files can be easily imported from the WavePulser 40iX or elsewhere into Eye Doctor and VirtualProbe tools in the oscilloscope
- Acquire waveforms at any point in the signal path, then use VirtualProbe to cleanly embed the effects of the channel
- Use the full analysis capability of SDA Expert Complete to compare eye, jitter and noise measurements at multiple test points simultaneously



Emulate Transmitter and Receiver Equalization

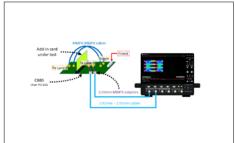
- SDA Expert Complete with Eye Doctor enables the emulation of all common equalization types, including:
 - Transmitter emphasis
 - Receiver FFE
 - Receiver CTLE
 - Receiver DFE

PCI EXPRESS® TESTING THAT CROSSES THE LAYERS

Teledyne LeCroy is the only company that provides PCle® testing across the layers – protocol to physical – while also providing superior instruments with sophisticated jitter, eye diagram, debug and compliance software.

- Automated transmitter, receiver and link equalization (LEQ) testing with QualiPHY 2 software options
- Visibility from physical layer through protocol operations
- Teledyne LeCroy is gold suite certified for all relevant PCI Express electrical compliance tests

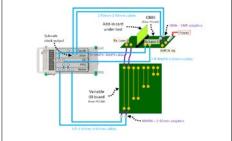




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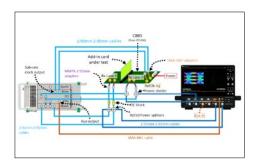
Transmitter (Tx) Testing

- Base specification and compliance testing for add-in cards and systems in CEM, M.2 and U.2 form factors
- QualiPHY 2 fully automates collection and processing of transmitter waveforms
- Supports TF-PCIE4-CTRL controller for full fixture and DUT automation
- Debug electrical compliance issues faster with SDA Expert software



Receiver (Rx) Testing

- Receiver calibration and testing using the WaveMaster 8000HD and Anritsu MP1900A BERT
- QualiPHY controls both the WaveMaster 8000HD and MP1900A
- Use WavePulser 40iX for receiver channel characterization and calibration
- Single QualiPHY 2 user interface for Tx and Rx testing



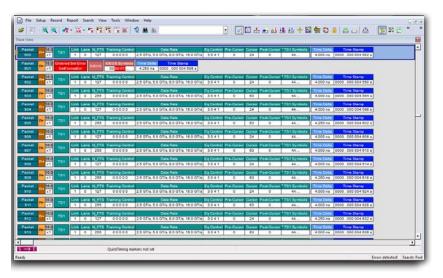
Link Equalization (LEQ) Testing

- Fully automated Tx and Rx LEQ testing using QualiPHY 2 with SigTest integration
- Test fixture and DUT automation for fast throughput
- Go directly from compliance test to cross-layer debug using ProtoSync on the WaveMaster 8000HD and LTSSM analysis on the MP1900A
- Link the WaveMaster 8000HD with a protocol analyzer using CrossSync PHY for deeper interoperability debug



Simplified PCIe Link Testing with CrossSync PHY

- Validate and debug active link operation
- Quickly resolve interoperability issues by capturing the entire protocol stack
- Analyze PCle link training with integrated physical and protocol views



Most Confidence for PCIe Testing

- Solutions for all PCle compliance tests and CXL compliance tests
- Fully automated transmitter, receiver and link equalization testing
- Easily transition from PCIe compliance testing to debug with SDA Expert



Built-in PCIe Expertise Using SDA Expert

- Comprehensive eye diagram, jitter and other PCIe measurements
- Simple, powerful transmitter equalization analysis
- Most complete Signal-to-Noise-and-Distortion Ratio (SNDR) analysis

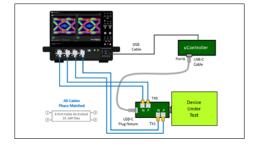
THE BEST OSCILLOSCOPE FOR USB-C TECHNOLOGY TESTING

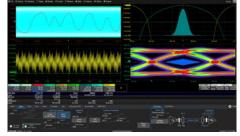
The WaveMaster 8000HD oscilloscope combines high-speed and sideband testing into a single instrument, making it the only oscilloscope that performs PHY compliance testing *and* gives you the power to go beyond compliance to debug USB Type-C® system interoperability failures.

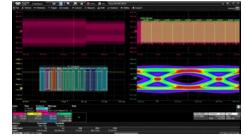
Complete PHY and PHY-logic layer oscilloscope solutions for USB4®, Thunderbolt™, USB 3.2/2.0, DisplayPort 2.1 and USB Power Delivery, all over the USB Type-C Connector.

- USB-IF and VESA approved compliance software
- Built-in USB-C test expertise for measuring and characterizing signals
- Simplify USB-C link testing with cross-layer analysis









Fastest PHY Compliance

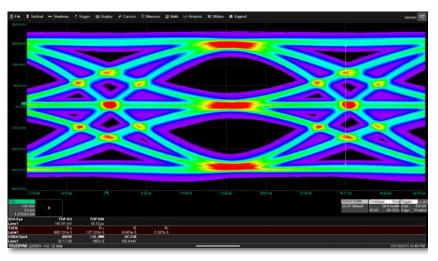
- QualiPHY software automates all Multi-lane USB-C transmitter (Tx) and receiver (Rx) compliance tests using a single, friendly user interface
- Fully automated, easy to set up testing
- USB4 SigTest automation without transferring waveforms to a PC
- Accurate Rx calibration and BER testing with Anritsu MP1900 BERT

Built-in SDA Expert Analysis

- Teledyne LeCroy builds decades of industry standard expertise into SDA Expert serial data analysis software. Simply:
 - 1. Select the standard under test
 - 2. Configure the desired test point
 - 3. Enable standard-specific measurements
- WavePulser 40iX simplifies and speeds up receiver channel characterization and calibration

Cross-layer Analysis

- See the whole link with CrossSync PHY for USB4 and Thunderbolt
- Trigger on USB4 sideband messages using USB4-SB TDMP, and debug highspeed with USB4bus DME
- High-speed serial decode and analysis using USB32 bus D, USB2bus TDME and ProtoSync software
- Sideband and power delivery debug using USB-PD TDMP and DisplayPort-AUX TDMP



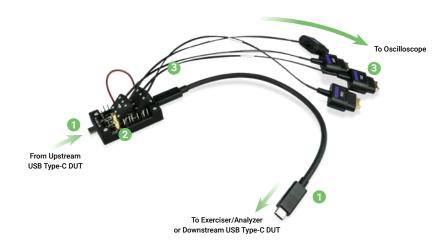
USB Type-C PHY Compliance

- QPHY2-USB4-TX-RX and QPHY-DP20-SOURCE/SINK automate transmitter and receiver compliance testing for USB4 version 2.0 (Gen2/Gen3/Gen4) and DisplayPort 2.1 standards, data rates ranging from 10 Gb/s NRZ up to 40 Gb/s PAM3
- Integrates USB4 ETT, USB4 Controller and SigTest Analysis for USB4, while also supporting 3rd-party fixtures and AUX controllers for DisplayPort over USB-C testing
- Fully automates receiver calibration and test with the Anritsu MP1900A high-speed BERT



Legacy Connector PHY Compliance

- QPHY-USB3.2-TX-RX, QPHY-USB and QPHY-DP20-SOURCE/SINK automate transmitter and receiver compliance testing for not only USB-C but all other connectors and data rates
- Supports all approved test fixtures, multiple test generators and DUT controllers for automated device control



USB-C System Level Debug

The TF-USB-C High-speed and Sideband Test Coupon Fixture provides signal access at the USB-C connector for cross-layer analysis.

- 1. Transparent signal path through plug, receptacle and C-C cable
- 2. Vbus (voltage and current) and sideband signal access using passive and active probes
- High-speed TX/RX signal access using DH series active differential probes

FASTEST DDR TEST JOURNEY

The DDR test path can be quickly traveled when the right tools are designed for engineers. This enables smooth transitions between different stages of design: from DDR turn-on and initial validation testing to fine-tuning, optimizing and pre-compliance. Accelerating testing confidence enables compliance tests to be done quickly and easily. Teledyne LeCroy covers JEDEC standards DDR2/3/3L/4/5 and LPDDR2/3/4/4X.



1. Interposers and Probes

- Interposers from reliable partners
- DH series probes with solder-in tips

2. External Mixed-signal "Logic Analyzer"

- Market's only trigger & decode up to DDR5
- Validate 20+ Command Address packets
- Highest accuracy for Read/Write separation

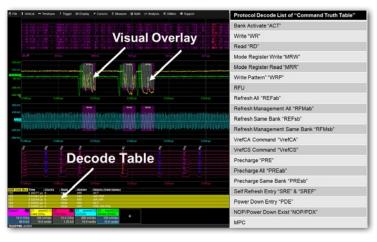
3. Tools for Turn-on Through Pre-compliance

- Multi-scenario viewing fast-tracks testing
- Exclusive toolkit with JEDEC defined measurements
- Eliminate signal quality errors with virtual probing

4. Automated DDR Compliance Testing

- Measure to the latest JEDEC specification
- Increase repeatability & test consistency
- Save Pass/Fail reports with screenshots

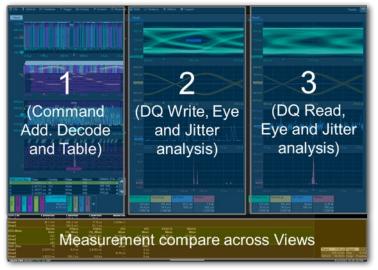
DDR5 BUNDLE INCLUDES QUALIPHY & DEBUG TOOLKIT



Decode and Trigger

Establishing basic operation, signal checks and responses is the foundation of board turn-ons. Decode the command bus to understand if it's correctly communicating and know if Read and Write packets are present.

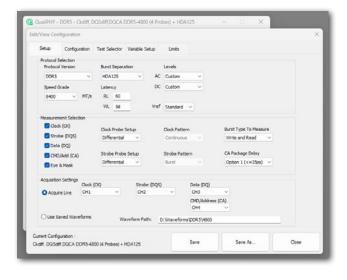
- Industry's only decode & trigger up to DDR5
- Decode 20+ packets from JEDEC Command Truth Table
- Perform better R/W separation using the command bus
- Overlay Read/Write visuals on channels
- Trigger on six different bus packet types



Multiple Scenario Viewing Areas

DDR stability occurs when the DRAM has been fine-tuned and optimized. This occurs when the voltage and timing parameters have been adjusted and measured for peak performance.

- Fast-track tuning stages with unique comparisons
- Interactively perform eye diagram, mask and JEDEC specific measurements on each view
- High-speed external MSO (HDA125) enables the highest accuracy for Read & Write packet separation.



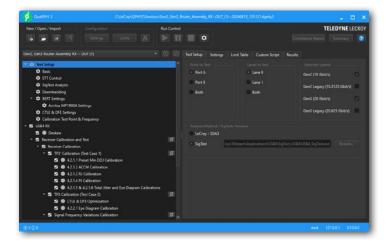
Automated Compliance Testing

QualiPHY automated compliance testing enables faster test times by reducing inconsistencies, testing to the JEDEC standard and allows users to quickly stop and rootcause failures with the DDR Debug Toolkit.

- DDR5 JEDEC measurements for DQ, DQS, CK, CA signals
- Supports System Level testing at the BGA
- Save Pass/Fail reports with annotated screenshots.
- Analyze compliance failures in a dedicated Debug Toolkit

QUALIPHY AND QUALIPHY 2 TEST AUTOMATION

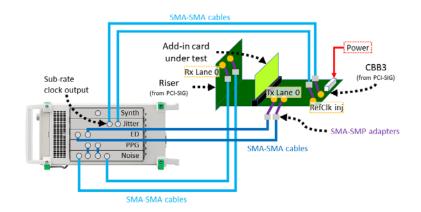
QualiPHY automated compliance test frameworks perform standardized physical layer tests on high-speed serial buses and other interfaces. QualiPHY or QualiPHY 2 software runs on Teledyne LeCroy oscilloscopes and is available for PCI Express®, USB, Thunderbolt™, DDR, DisplayPort™, HDMI® and other technologies.



Simplified Set Up

QualiPHY dialogs help the user configure all aspects of test execution, including:

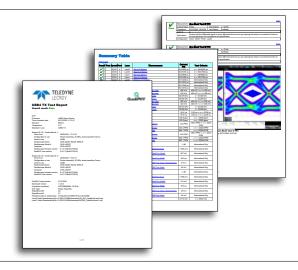
- Selecting the set of tests to run
- Configuring test parameters
- Customizing limits
- Options to stop after each test or execute sequentially



Streamlined Test Execution

QualiPHY guides the user though connection and execution of each test, resulting in increased repeatability.

- Clear, informative connection diagrams help simplify complex test setups and reduce mistakes
- Test automation using powerful Pythonenabled program control (QualiPHY 2 products) or Host Program Control (selected QualiPHy products)
- QPHY2-PC processes waveform data offline and frees the oscilloscope for other testing.



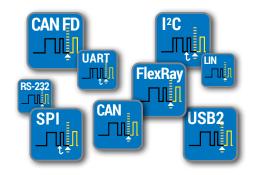
Informative Reporting

QualiPHY produces comprehensive reports documenting test results.

- Save reports in PDF or HTML format
- Screenshots and tabular results included
- Summary table at the start of the report makes it easy to tell pass/fail results at a glance

COMPREHENSIVE LOW-SPEED SERIAL SOLUTIONS

Teledyne LeCroy's Trigger (T), Decode (D), Measure/Graph (M) and Eye Diagram (E) or Physical Layer (P) options are the best of their kind. Visit teledynelecroy.com/tdme for complete details.



Highest Performance Triggers

Designed by people who know the standards, with the unique capabilities you need to isolate unusual events.

- Powerful, flexible, unique
- Conditional data setup
- Support for proprietary protocols



The Most Intuitive Serial Decoder

Decoded protocol information is marked by transparent, colored overlays for an intuitive, easy-to-understand visual record. Navigate the decoding using a single, time-interleaved table with "touch to zoom."

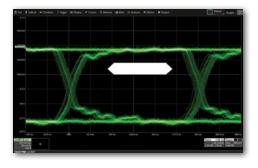
- Intuitive, color-coded overlays
- Pattern search
- Interactive table summarizes results



Measure and Graph Tools for Validation Efficiency

Automated timing measurements quickly validate cause and effect and serial data digital-to-analog (DAC) converter enhances understanding.

- Automated timing measurements
- Serial data DAC and graphing tools
- Bus status measurements



Eye Diagrams and Physical Layer Testing

Rapidly display an eye diagram of low-speed serial data signals. Eye parameters quantify system performance, and eye masks identify anomalies.

- Up to four simultaneous eye diagrams
- Eye measurements and masks
- Advanced PHY measurements

HIGH BANDWIDTH DIFFERENTIAL PROBES

The DH series of 8 to 30 GHz active differential probes provides high input dynamic range, large offset capability, low loading and excellent signal fidelity with a range of connection options.

General Purpose Probing up to 30 GHz

Teledyne LeCroy's DH series 8 GHz to 30 GHz differential probes offer the combination of bandwidth, input range and offset capability to address any high-speed probing requirement - from debugging serial data interfaces to validating DDR memory systems.

Exceptional Signal Fidelity

DH series probes provide superior loading characteristics and are calibrated with a custom "fine-tuned" frequency response. The ultra-low loading and flat frequency response ensure accurate measurements.

Wide Variety of Tips

Two 30 GHz solder-in leads let you choose between a 3.5 Vpp input range for general-purpose applications, or high sensitivity with exceptionally low noise. Also available are a 1-meter long 16 GHz high-temperature tip, a 16 GHz handheld browser tip and an 8 GHz QuickLink adapter for connecting mixed-signal probe tips.



Tip Identification

Each DH series tip has its own data onboard - the oscilloscope software automatically selects the correct tip type and precisely corrects for its effects. The result is superior signal fidelity and superior ease-of-use.

Digital Logic Probing Options

HDA125 High-speed Digital Analyzer

The HDA125 turns your Teledyne LeCroy oscilloscope into the highest-performance, most flexible mixed-signal solution with 12.5 GS/s digital sampling rate (3 GHz digital clock rate) on 18 input channels and the QuickLink probing solution. Ideal for validation of DDR interfaces.



BROAD RANGE OF PROBING SOLUTIONS

WaveMaster 8000HD oscilloscopes support a broad range of probes for a variety of applications.

Differential Probes (200 MHz – 1.5 GHz)



Wide dynamic range, low loading and excellent noise performance. From 200 MHz to 1.5 GHz. Specialty AP033 provides 10x gain and high CMRR.

Differential Probes (4 – 6 GHz)



5 Vp-p dynamic range with ±3 V offset and low noise and loading. Solderin, browser, QuickLink, Quick Connect, square pin and HiTemp leads/tips.

Differential Probes (8 – 30 GHz)



For serial data, DDR or other high-speed signals. Standard and high-sensitivity solder-in, HiTemp, and QuickLink for mixed-signal probing.

60 V Common Mode Differential Probes



The ideal probes for lower voltage GaN power conversion measurement with the highest accuracy, best CMRR and lowest noise. Up to 1 GHz.

High Voltage
Differential Probes



 $1~\rm kV, 2~\rm kV$ and $6~\rm kV$ CAT safety rated models. Widest differential voltage ranges, exceptional CMRR, low noise, 1% gain accuracy.

High Voltage
Optically Isolated
Probes



Ideal for GaN and SiC devices. Highest accuracy, most bandwidth, wide range of voltages, optical isolation.

High Voltage
Passive Probes



1 kV to 6 kV ratings. Provides ground-referenced high voltage measurements for a wide range of applications.

Active Voltage Probes



1 to 4 GHz models. High signal fidelity and low circuit loading (<1 pF tip capacitance), ±8 V dynamic range, ±12 V offset.

Active Voltage/Power Rail Probe



 $4\,\text{GHz}$ bandwidth, $\pm 60\,\text{V}$ offset, $\pm 800\,\text{mV}$ dynamic range. High DC input impedance and low noise/attenuation for power rail probing.

Current Probes



For AC, DC and impulse current measurements. Utilizes combination of Hall effect and transformer technology. Up to 500 A, up to 100 MHz.

Rogowski Coil Probes



Wide frequency range and small sense coils for maximum flexibility. From $300\ to\ 6000\ Amps$, as low as $0.1\ Hz$ to as high as $30\ MHz$.

Transmission Line Probes



High-bandwidth passive probe for use with 50 Ω inputs. DC to 7.5 GHz with 0.25 pF input capacitance. 10x or 20x attenuation.

Probe and Current Sensor Adapters



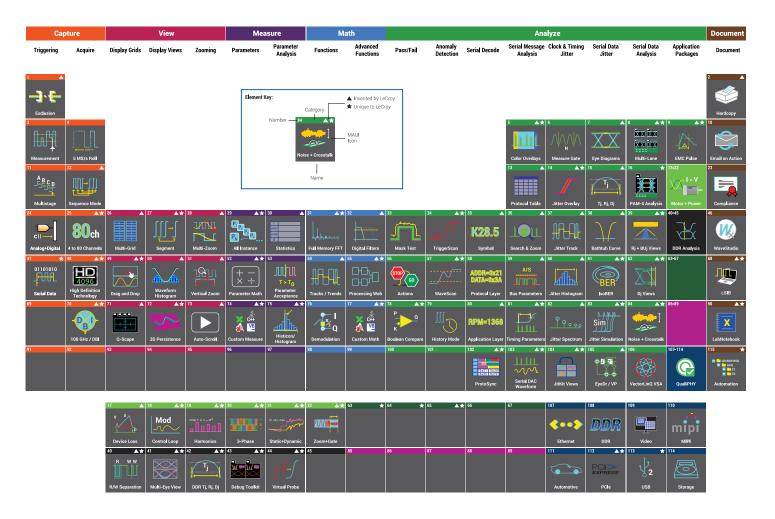
Change between the different Teledyne LeCroy Oscilloscope input types or provide a simple interface to 3rd-party probes.

Passive Probes



10x attenuating with $10\;\text{M}\Omega$ input resistance. Ideal for low-frequency signals.

POWERFUL, DEEP TOOLBOX



Our Heritage

Teledyne LeCroy's 50+ year heritage is in processing long records to extract meaningful insight. We invented the digital oscilloscope and many of the additional waveshape analysis tools.

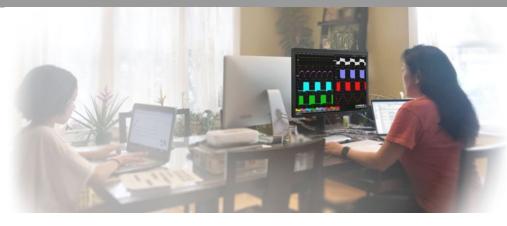
Our Obsession

Our tools and operating philosophy are standardized across much of our product line. This deep toolbox inspires insight; and your moment of insight is our reward.

Our Invitation

Our Periodic Table of Oscilloscope
Tools explains the toolsets that
Teledyne LeCroy has deployed in our
oscilloscopes. Visit our interactive
website to learn more about them.
teledynelecroy.com/tools

MAUI STUDIO - WORKS WHERE YOU ARE



Unleash the power of a
Teledyne LeCroy oscilloscope
anywhere, using a PC with MAUI
Studio Pro. Work remotely from
your oscilloscope and collaborate
with ease.

Flexibility to Work Anywhere

MAUI Studio provides the flexibility to work remotely. It allows anyone, anywhere to execute real-time analysis by connecting to an oscilloscope through an Ethernet connection or by analyzing a saved LabNotebook.

Collaborate with Ease

Using MAUI Studio, you can share a LabNotebook file saved from an oscilloscope with all your colleagues, and everyone will have access to the same software options that are found on your oscilloscope.

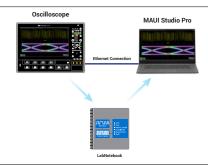
The Power of MAUI Studio

Get all the unbelievable analytical capabilities of your oscilloscope on your PC. MAUI Studio has all the tools needed to analyze complex waveform data, enabling your lab's oscilloscopes to be freed up for other activities.



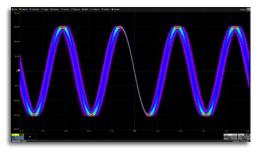
Remote Connection

- Connect to an oscilloscope through an Ethernet connection
- Transfer waveforms and setups from an oscilloscope to MAUI Studio Pro
- Transfer setups from MAUI Studio Pro to an oscilloscope
- Import software options by establishing a remote connection to an oscilloscope



Offline Analysis

- Recall a LabNotebook file to analyze saved waveforms, measurements and setups
- Import software options by recalling a LabNotebook file
- Have access to the same software found on your oscilloscope



Arbitrary Function Generator

- Generate advance waveforms using the AFG
- Easily generate a PAM4 signal
- Add jitter to a clock signal to simulate real-world signal integrity impairments

W	WaveMaster/SDA 8060HD	WaveMaster/SDA 8080HD	WaveMaster/SDA 8130HD	WaveMaster/SDA 8160HD	WaveMaster/SDA 8200HD
Vertical System					
Analog Bandwidth @ 50 Ω (-3 dB) (ProLink/ProAxial Input)	6 GHz	8 GHz	13 GHz	16 GHz	20 GHz (≥5 mV/div) ProLink input connectors
Analog Bandwidth @ 50 Ω (-3 dB)	2 GHz (≥10 mV/div)				
(ProBus Input) Analog Bandwidth @ 1 MΩ (-3 dB)	500 MHz (typical, ≥2 m	iV/div)			
(ProBus Input) Rise Time (10-90%, 50 Ω - typical)	77 ps	55 ps	34 ps	28 ps	19.1 ps
,	(Flatness mode)	(Flatness mode)	(Flatness mode)	(Flatness mode)	(flatness mode)
Rise Time (20–80%, 50 Ω - typical)	54 ps (Flatness mode)	39 ps (Flatness mode)	24 ps (Flatness mode)	19 ps (Flatness mode)	13.2 ps (flatness mode)
Input Channels	4 (Any combination of	ProLink and ProBus inp	outs)		
Vertical Resolution		ith enhanced resolution		F 40	6 1 4
Effective Number of Bits (ENOB)* Vertical Noise Floor (rms, typical, 50 Ω)	6.37	6.07	5.60	5.49	6.14
5 mV/div 10 mV/div	291 µVrms 291 µVrms	422 μVrms 422 μVrms	549 µVrms 549 µVrms	584 µVrms 584 µVrms	376 µVrms 376 µVrms
20 mV/div	380 µVrms	498 µVrms	672 µVrms	712 µVrms	502 μVrms
50 mV/div	889 µVrms	948 µVrms	1.28 mVrms	1.36 mVrms	1.17 mVrms
100 mV/div 200 mV/div	1.70 mVrms 3.50 mVrms	2.04 mVrms 4.73 mVrms	2.55 mVrms 6.50 mVrms	2.63 mVrms 6.80 mVrms	2.32 mVrms 4.48 mVrms
500 mV/div	8.72 mVrms	10.21 mVrms	13.05 mVrms	13.57 mVrms	11.06 mVrms
1 V/div	16.81 mVrms	19.70 mVrms	25.50 mVrms	26.00 mVrms	21.95 mVrms
* Average value across bandwith, input signal &					
Sensitivity	50 Ω (ProLink):	riabla			
	5 mV - 1 V/div, fully va	riable			
	50 Ω (ProBus): 2 mV - 1 V/div, fully va 1 MΩ (ProBus): 2 mV - 10 V/div, fully v				
DC Vertical Gain Accuracy (Gain Component of DC Accuracy)	±0.5% F.S. (typical), off ±1.2% F.S. (test limit), o ±1.5% F.S. (test limit), o	set at 0 V; offset at 0 V with ProBu offset at 0 V with ProLin	s inputs; k/ProAxial inputs		
Channel-Channel Isolation	ProLink/ProAxial inpu DC to 20 GHz: 60 dB (
	ProBus inputs: DC to 200 MHz: 70 dB	(>2000:1)			
	200 to 500 MHz: 60 dB	· //			
	500 MHz to 1 GHz: 50				
	1 GHz to 2 GHz: 40 dB	'''			
	(For any two input cha	nnels, same V/div setti	ngs, typical)		
Offset Range	50 Ω (ProLink/ProAxia ±500 mV @ 5 - 100 m\ ±4 V @ 102 mV/div - 1	//div			
	50 Ω (ProBus):	v, aiv			
	±1.6 V @ 1 mV - 4.95 n	nV/div			
	±4 V @ 5 mV - 9.9 mV/ ±8 V @ 10 mV - 19.8 m ±10 V @ 20 mV - 1 V/d	div V/div			
	1 MΩ (ProBus): ±1.6 V @ 1 mV - 4.95 n ±4 V @ 5 mV - 9.9 mV/ ±8 V @ 10 mV - 19.8 m ±16 V @ 20 mV - 100 n ±80 V @ 102 mV - 198	div IV/div nV/div			
	±160 V @ 200 mV - 1 V ±400 V @ 1.02 V - 10 V	//div			

	WaveMaster/SDA 8250HD	WaveMaster/SDA 8330HD	WaveMaster/SDA 8500HD	WaveMaster/SDA 8590HD	WaveMaster/SDA 8650HD
Vertical System Analog Bandwidth @ 50 Ω (-3 dB)			50 GHz	59 GHz	65 GHz
_(1.85 mm Input) Analog Bandwidth @ 50 Ω (-3 dB) (ProAxial Input)	25 GHz (≥5 mV/div) ProAxial input	33 GHz (≥5 mV/div) ProAxial input	(≥10 mV/div)	(≥10 mV/div) 33 GHz (≥5 mV/div)	(≥10 mV/div)
Analog Bandwidth @ 50 Ω (-3 dB)	connectors 2 GHz	connectors			
(ProBus Input) Analog Bandwidth @ 1 MΩ (-3 dB)	(≥10 mV/div) 500 MHz (typical, ≥2 m	nV/div)			
<u>(ProBus Input)</u> Rise Time (10 - 90%, 50 Ω - typical)	15.9 ps (flatness mode)	12.6 ps (flatness mode)	8.2 ps (flatness mode)	6.8 ps (flatness mode)	6.5 ps (flatness mode)
Rise Time (20 - 80%, 50 Ω - typical)	10.3 ps (flatness mode)	7.8 ps (flatness mode)	6.2 ps (flatness mode)	5.1 ps (flatness mode)	4.9 ps (flatness mode)
Input Channels	4 (Any combination o	of ProAxial and ProBusuuts)	4 (Any comb 3 (A combination of or	ination of 33 GHz ProA 2 GHz ProBus inputs), ie 1.85mm input @ full its), or 2 (1.85mm input	xial inputs or BW and two ProLink or
Vertical Resolution Effective Number of Bits (ENOB)*	12 bits; up to 15 bits w 5.96	ith enhanced resolution 5.62	(ERES) 5.24	5.09	5.05
Vertical Noise Floor (rms, 50 Ω)					
5 mV/div	454 μVrms 454 μVrms	502 µVrms	700 u\/rma	 201 u/rma	076 u\/rma
10 mV/div 20 mV/div	454 μVrms 592 μVrms	502 µVrms 624 µVrms	799 µVrms 1.01 µVrms	894 µVrms 1.07 mVrms	976 µVrms 1.42 mVrms
50 mV/div	1.31 mVrms	1.36 mVrms	2.09 mVrms	2.25 mVrms	2.41 mVrms
100 mV/div	2.59 mVrms	2.72 mVrms	3.69 mVrms	3.95 mVrms	4.31 mVrms
200 mV/div	5.15 mVrms	5.54 mVrms			
500 mV/div 1 V/div	12.51 mVrms	12.89 mVrms			
۱ ۷/۵۱۷ Average value across bandwith, input sign	al 80% of full scale				
Sensitivity	Sensitivity 50 Ω (ProAxial): 5 mV - 500 mV/div, for variable		50 Ω (1.85mm): 10 mV - 100 mV/div, fully variable 50 Ω (ProAxial): 5 mV - 500 mV/div, fully variable 50 Ω (ProBus): 2 mV - 1 V/div, fully variable		
		- 1 V/div, fully variable - 10 V/div, fully variable	1 MO (Drol	Bus): 2 mV - 10 V/div, fu	
DC Vertical Gain Accuracy	±0.5% F.S. (typical), off	set at 0 V;			
(Gain Component of DC Accuracy)	±1.2% F.S. (test limit), 0	offset at 0 V with ProBu	S INPUTS; am/ProAvial inputs		
Channel-Channel	ProLink/Pro	Axial inputs:	IIII/I TOAXIAI IIIputs	1.85 mm inputs:	
Isolation		60 dB (>1000:1)		to 33 GHz: 60 dB (>100 to 65 GHz: 40 dB (>100	
		inputs: 70 dB (>3000:1),		ProAxial inputs:	
		60 dB (>1000:1),	DC 1	o 33 GHz: 60 dB (>100	00:1)
		z: 50 dB (>300:1),		, , , , , , , , , , , , , , , , , , , ,	,
		: 40 dB (>100:1)		ProBus inputs:	
	1 0112 to 2 0112	40 dB (* 100.1)	DC to	200 MHz: 70 dB (>300	00:1),
	(For any two input obo	nnels, same V/div set-	200 t	o 500 MHz: 60 dB (>10	00:1),
		typical)	500 N	1Hz to 1 GHz: 50 dB (>3 Hz to 2 GHz: 40 dB (>10	300:1),
				it channels, same V/div	•
Offset Range	50 Ω (ProLir	nk/ProAxial):	,	50 Ω (1.85mm):	3 , .)
	_	5 - 100 mV/div /div - 500 mV/div	±5	00 mV @ 10 - 100 mV/	div
	Q - ,		!	50 Ω (ProLink/ProAxial)):
	50 Ω (P	ProBus):	±;	500 mV @ 5 - 100 mV/d	liv
	±1.6 V @ 1 m\	/ - 4.95 mV/div	±4 V	@ 102 mV/div - 500m\	V/div
	±4 V @ 5 mV	/ - 9.9 mV/div			
		/ - 19.8 mV/div		50 Ω (ProBus):	
	±10 V @ 20	mV - 1 V/div		.6 V @ 1 mV - 4.95 mV/	
	1 MO (F	ProBus):		4 V @ 5 mV - 9.9 mV/d	
		/ - 4.95 mV/div	18	V @ 10 mV - 19.8 mV/ ±10 V @ 20 mV - 1 V/di	uiv V
	±4 V @ 5 mV	/ - 9.9 mV/div		@ <u>2</u> 0 1117 1 1/d1	
		/ - 19.8 mV/div		1 MΩ (ProBus):	
		V - 100 mV/div nV - 198 mV/div		.6 V @ 1 mV - 4.95 mV/	
		0 mV - 1 V/div		4 V @ 5 mV - 9.9 mV/d V @ 10 mV - 19.8 mV/	
		02 V - 10 V/div	±1	6 V ั@ 20 mV - 100 mV/	'div
			±80) V @ 102 mV - 198 mV	/div
				160 V @ 200 mV - 1 V/c	
DC Vertical Offset Accuracy		+ 1% FS + 1 m\/) (test l	<u>±</u> ,	<u>400 V @ 1.02 V - 10 V/c</u>	IIV

	WaveMaster/SDA 8060HD	WaveMaster/SDA 8080HD	WaveMaster/SDA 8130HD	WaveMaster/SDA 8160HD	WaveMaster/SDA 8200HD	
Vertical System						
Maximum Input Voltage	50 Ω (ProLink/ProAxia 50 Ω (ProBus): ≤5 Vrm 1 MΩ (ProBus): 1 MΩ	IS C	nV/div, 5.5 Vrms @ > 10	00 mV/div		
Input Coupling	ProLink/ProAxial Inpu 50 Ω: DC, GND ProBus Inputs: 1 ΜΩ: AC, DC, GND; 50					
Input Impedance	ProLink/ProAxial Inpu ProBus Inputs: 50 Ω ±		MΩ 10 pF with supplie	ed passive probe		
Bandwidth Limiters	50 Ω (ProLink/ProAxial): Fully variable from 1 GHz to instrument bandwidth in increments of 100 MHz 50 Ω (ProBus): 200 MHz, 20 MHz, Fully variable from 1 GHz to 2 GHz in increments of 100 MHz 1 MΩ (ProBus): 200 MHz, 20 MHz					
Rescaling	arcdegr, arcmin, arcsec ft/s2, g0; Volume: liters pound; Pressure: pasc volt-amperes, volt-amp meter, power factor; M	s, cycles, revolutions, tur s, cubic meters, cubic in al, bar, atmosphere (tec peres reactive, farad, cou agnetic: weber, tesla, he	s: grams, slugs; Temper ns; Velocity: m/s, in/s, f ches, cubic feet, cubic y nnical), atmosphere (sta dlomb, ohm, siemen, volt enry, amp/meter, henry/r /second, revolution/min	t/s, yd/s, miles/s; Acce ards; Force (Weight): n Indard), torr, psi; Electric t/meter, coulomb/m2, f meter; Energy: joule, Bti	ewton, grain, ounce, cal: volts, amps, watts, arad/meter, siemen/ u, calorie; Rotating	
Horizontal - Analog Channels						
Timebases		mon to 4 input channel		6.1.5		
Time/Division Range	20 ps/div - 5000 s/div	(maximum capture time	e is based on minimum	sample rate of 1 kS/s a	and installed memory)	
Clock Accuracy	<0.1 ppm + (aging of 0	.05 ppm/yr from last ca	libration)			
Sample Clock Jitter	up to 10 µs Acquired T up to 100 µs Acquired	ïme Range: 28 fsrms (II Time Range: 32 fsrms (ernal Timebase Referer nternal Timebase Refere Internal Timebase Refe ternal Timebase Refere	ence) rence)		
Delta Time Measurement Accuracy	$\sqrt{2} * \sqrt{\left(\frac{Noise}{SlewRate}\right)^2} +$	(Sample Clock Jitter) ² (RN	IS) + (clock accuracy * readir	ng) (seconds)		
Jitter Measurement Floor	√ \ SlewRate	(Sample Clock Jitter) ² (RN				
Jitter Between Channels*	≤ 320 fs _{rms}	≤ 305 fs _{rms}	≤ 275 fs _{rms}	≤ 255 fs _{rms}	≤185 fs _{rms}	
Skew stability Between Channels	05	10 fs _{ms}	(typical)		7.5 fs _{rms} (typical)	
Channel-Channel Deskew Range External Timebase Reference (Input)	25 ns 10 MHz: 50 0 impedan	ice, applied at the rear i	nnut			
External Timebase Reference (Output)	10 MHz; 50 Ω impedar		the said			

^{*} Typical value, measured at full bandwidth

	WaveMaster/SDA 8250HD	WaveMaster/SDA 8330HD	WaveMaster/SDA 8500HD	WaveMaster/SDA 8590HD	WaveMaster/SDA 8650HD
Vertical System					
Maximum Input Voltage	5.5 Vrms @ 50 Ω (ProB i	Vmax @ ≤ 100 mV/div, > 100 mV/div us): ≤5 Vrms Ω // 20pF ≤400 Vpeak	50 Ω (1.85mm): ±2 V Vmax 50 Ω (ProAxial): ±2V Vmax @ ≤ 100 mV/div, 5.5 Vrms @ > 100 mV/div 50 Ω (ProBus): ≤5 Vrms 1 ΜΩ (ProBus): 1 ΜΩ 20 pF ≤400 Vpeak		
Input Coupling	ProAxial/1.85mm Inpu 50 Ω: DC, GND ProBus Inputs: 1 MΩ: AC, DC, GND; 50			9949): Titisk 20 pr =	ioo ypsaii
Input Impedance	ProAxial Inputs: 50 Ω:	±2.5% 2% or 1 MΩ 20 pF, 10	1.85mm Inputs: $50 \Omega \pm$ ProAxial Inputs: $50 \Omega \pm$ ProBus Inputs: $50 \Omega \pm$ supplied passive probe	±2.5% 2% or 1 MΩ 20 pF, 10	MΩ 10 pF with
Bandwidth Limiters	50 Ω (ProAxial): Fully	variable from 1 GHz to Hz, 20 MHz, Fully variat	nstrument bandwidth ii 33 GHz in increments o ble from 1 GHz to 2 GHz	n increments of 100 M f 100 MHz	
Rescaling	Length: meters, inches arcdegr, arcmin, arcsec ft/s2, g0; Volume: liters pound; Pressure: pasc volt-amperes, volt-amp meter, power factor; M	s, feet, yards, miles; Mas c, cycles, revolutions, tui s, cubic meters, cubic in al, bar, atmosphere (tec peres reactive, farad, cou agnetic: weber, tesla, he	s: grams, slugs; Temper rns; Velocity: m/s, in/s, f ches, cubic feet, cubic y hnical), atmosphere (sta ulomb, ohm, siemen, voli enry, amp/meter, henry/r /second, revolution/min	t/s, yd/s, miles/s; Acce ards; Force (Weight): n Indard), torr, psi; Electric t/meter, coulomb/m2, f meter; Energy: joule, Btu	ewton, grain, ounce, cal: volts, amps, watts, arad/meter, siemen/ u, calorie, Rotating
Horizontal - Analog Channels					
Timebases Time/Division Range	For >33 GHz Mode: 20 For ≤33 GHz Mode: 20 and installed memory	ps/div - 5000 s/div (m	kimum capture time is b aximum capture time is		2,
Clock Accuracy Sample Clock Jitter	up to 1 µs Acquired Tir up to 10 µs Acquired T up to 100 µs Acquired	ïme Range: 28 fsrms (II Time Range: 32 fsrms (alibration) ernal Timebase Referer nternal Timebase Refere Internal Timebase Refe ternal Timebase Refere	ence) rence)	
Delta Time Measurement Accuracy	$\sqrt{2} * \sqrt{\left(\frac{Noise}{SlewRate}\right)^2} +$	(Sample Clock Jitter) ² (RN	1S) + (clock accuracy * readir	ng) (seconds)	
Jitter Measurement Floor	$\sqrt{\left(\frac{Noise}{SlewRate}\right)^2}$ +	(Sample Clock Jitter) ² (RN			
Jitter Between Channels*	≤ 173 fsrms	≤ 156 fsrms	≤118 fs _{rms}	≤98 fs _{rms}	≤85 fs _{rms}
Skew stability Between Channels Channel-Channel Deskew Range External Timebase Reference (Input) External Timebase Reference (Output)		nce, applied at the rear in			

^{*} Typical value, measured at full bandwidth

	WaveMaster/SDA 8060HD	WaveMaster/SDA 8080HD	WaveMaster/SDA 8130HD	WaveMaster/SDA 8160HD	WaveMaster/SDA 8200HD
Acquisition - Analog Channels					
Sample Rate (Single-Shot)		80 GS/s on 4 Ch with I	Enhanced Sample Rate		160 GS/s on 4 Ch with Enhanced Sample Rate
Memory Length (4 Ch)	Standard: 200 Mpts 500MPT option (stand 500 Mpts 2000MPT option: 2000 Mpts 8000MPT option: 8000 Mpts	lard in SDA models):			
Number of Segments in Sequence Ac-	65,535				
quisition Mode					
Intersegment Time	1 μs				
Averaging		<u>1 million sweeps; contir</u>	nuous averaging to 1 mi	Illion sweeps	
Interpolation	Linear or Sin(x)/x				
Vertical Harimantal Association	Digital Channels				
Vertical, Horizontal, Acquisition -		KIID MOO antian		HDA125-18-LE	NIIO
	WIVIS	KHD-MSO option		HDA 125-18-LE	305
Maximum Input Frequency		500 MHz		3 GHz	
Minimum Detectable Pulse Width		1 ns		167 ps	
		± 20 V		±10 V on any single-er	nded input
Input Dynamic Range				±7.5 V max differ	
Input Impedance (Flying Leads)	1	100 kΩ 5 pF	C	L-SI tips: 110 kΩ, 0.12 p	F differential
Input Channels	161	Digital Channels		18 Digital Chan	nels
		±30 V Peak		±15 V on any single-er	nded input
Maximum Input Voltage				±15 V max differ	
Minimum Input Voltage Swing		400 mV		150 mV p-p	
	TTL, ECL, CMOS	(2.5 V, 3.3 V, 5 V), PECL,	LVDS	User Defined	
Threshold Selections	OI	User Defined			
	(00: 6:1	- l l - l ++: 100 \ /)	\pm (25 mV + 3% of thresh	
Threshold Accuracy		shold setting + 100 mV			
User-Defined Threshold Range	±10	V in 20 mV steps	+5	V. settable per channel	in 5 mV steps
User-Defined Threshold Range User-Defined Hysteresis Range	±10	V in 20 mV steps 1.4 V in 100 mV steps	+5	5V, settable per channel 0 mV to 600 mV settabl	in 5 mV steps
User-Defined Threshold Range	±10	V in 20 mV steps	+5	V. settable per channel	in 5 mV steps

Association Analog Channels	WaveMaster/SDA 8250HD	WaveMaster/SDA 8330HD	WaveMaster/SDA 8500HD	WaveMaster/SDA 8590HD	WaveMaster/SDA 8650HD
Acquisition - Analog Channels Sample Rate (Single-Shot)	160 GS/s with Enhanced	s on 4 Ch d Sample Rate	1.85mm inputs: 320 GS/s on 2 Ch with Enhanced Sample Rate; ProAxial/ProBus inputs: 160 GS/s on 4 Ch with Enhanced Sample Rate		
Memory Length Interleaved (1.85mm) / Non-interleaved (ProAxial/ProBus)	Standard: 200 Mpts 500MPT option (standard in SDA models): 500 Mpts 2000MPT option: 2000 Mpts 8000MPT option: 8000 Mpts			Standard: 400 Mpts / 200 Mpts 500MPT option (standard in SDA models): 1000 Mpts / 500 Mpts 2000MPT option: 4000 Mpts / 2000 Mpts 8000MPT option: 16000 Mpts / 8000 Mpts	
Number of Segments in Sequence Acquisition Mode Interseament Time	65,535 1 us				
Averaging Interpolation Vertical, Horizontal, Acquisition -	Summed averaging to Linear or Sin(x)/x	1 million sweeps; conti	nuous averaging to 1 mi	llion sweeps	
vertical, Horizontal, Acquistion		KHD-MSO option		HDA125-18-LI	BUS
Maximum Input Frequency Minimum Detectable Pulse Width	500 MHz 1 ns +20 V			3 GHz 167 ps ±10 V on any single-ended input	
Input Dynamic Range Input Impedance (Flying Leads) Input Channels	100 kΩ 5 pF		±7.5 V max differential QL-SI tips: 110 kΩ, 0.12 pF diffe		ential of differential
Maximum Input Voltage		Digital Channels ±30 V Peak		18 Digital Channels ±15 V on any single-ended input ±15 V max differential	
Minimum Input Voltage Swing Threshold Selections	400 mV TTL, ECL, CMOS (2.5 V, 3.3 V, 5 V), PECL, or User Defined			150 mV p-p User Defined	
Threshold Accuracy User-Defined Threshold Range User-Defined Hysteresis Range	±(3% of threshold setting + 100 mV) ±10 V in 20 mV steps 100 mV to 1.4 V in 100 mV steps		±5V, settable per channel in 5 mV		in 5 mV steps
Sample Rate Channel-to-Channel Skew		2.5 GS/s 350 ps		12.5 GS/s ±160 ps	

Time view Quature	WaveMaster/SDA 8060HD	WaveMaster/SDA 8080HD	WaveMaster/SDA 8130HD	WaveMaster/SDA 8160HD	WaveMaster/SDA 8200HD
Triggering System Modes	Acquisition of ≤500 M		le, and Stop		.
Sources	Acquisition of >500 M		dge. Slope and level uni	aue to each source (exc	cent line trigger)
Coupling	DC. AC. HFRei, LFRei			que to caen source (ext	sept line trigger).
Pre-trigger Delay	0 - 100% of memory si	ze (adjustable in 1% inc	rements of 100 ns)		
Post-trigger Delay	0 - 10,000 divisions in i	real-time mode, limited	at slower time/div settir	ngs	
Hold-off	From 2 ns up to 20 s o				
Trigger and Interpolator Jitter Internal Trigger Level Range	<0.1 ps rms (typical, so ±3 div from center (typ	ntware assisted), 2 ps r	ms (typicai, nardware)		
External Trigger Level Range	Aux (±0.4 V); Aux/10 (±				
Maximum Trigger Rate	>900,000 waveforms/s	second (in Seguence M	ode, up to 4 channels)		
Trigger Sensitivity with Edge Trigger	4 div @ ≤ 15 GHz				
ProAxial/ProLink inputs	3 div @ < 12 GHz				
	1.5 div @ < 3 GHz 1.0 div @ < 200 MHz				
	(for DC coupling, ≥ 10 i	mV/div_50.0.)			
Trigger Sensitivity with Edge Trigger	2.5 div @ <1 GHz	1117 (117, 00 12)			
ProBus Inputs	2 div @ <1 GHz				
	1.5 div @ <500 MHz				
	1 div @ <200 MHz				
	0.9 div @ <10 MHz				
E. IT. O. W.	(DC, AC, and LFRej cou	pling, ≥2 mV/div, 50 Ω)			
External Trigger Sensitivity,	3 div @ <2 GHz				
(Edge Trigger)	2.5 div @ <1 GHz 1.5 div @ <500 MHz				
	1 div @ <200 MHz				
	0 9 div ⋒ <10 MHz	\			
May Triangue François	(DC, AC, and LFRej cou	pling)			
Max. Trigger Frequency, SMART Trigger	2.0 GHz @ ≥10 mV/div (minimum triggerable				
- 33 -	(minimum triggerable	widti 200 ps)			
<u>Trigger Types</u>					
Edge	Triggers when signal n	neets slope (positive, ne	egative, or either) and le	vel condition.	unith and facility
Width Glitch	Triggers on positive, ne	pagative of both (widths	selectable as low as 200 hs selectable as low as	0 ps (0 20 s) or on inter 200 ps to 20 s) or on in	termittent faults
Window	Triggers when signal e	xits a window defined h	ov adjustable thresholds		
Pattern	Logic combination (AN	D, NAND, OR, NOR) of 5	inputs (4 channels and	external trigger input).	Each source can be
	high low or don't care	The high and low level o	can be selected indepen	dently Triggers at start	or end of the pattern
Runt	Trigger on positive or n	egative runts defined by	two voltage limits and t	wo time limits. Select be	etween 1 ns and 20 ns.
Slew Rate Interval	Trigger on edge rates.	select ilmits for dv, dt a electable between 1 ns	nd slope. Select edge lin	mils between i ns and	20 ns.
Dropout	Triggers of fifter vals si	out for longer than sel	ected time between 1 n:	s and 20 s	
Exclusion Triggering	Trigger on intermittent	faults by specifying the	e expected behavior and	triggering when that co	ondition is not met.
Measurement Trigger	Select from a large nur	nber of measurement p	parameters trigger on a	measurement value wit	th qualified limits. Can
Multi Otana Ovalifiad	be used as only trigger	or last event in a Casc	ade Trigger. state or edge occurred (I lala off hative an
Multi-Stage: Qualified	sources is selectable b	v time or events	state or edge occurred o	on another input source	e. Holdon between
Multi-Stage: Qualified First	In Sequence acquisition	n mode, triggers repeat	ably on event B only if a	defined pattern, state of	or edge (event A) is
	satisfied in the first seg	ment of the acquisition	n. Holdoff between sou	rces is selectable by tin	ne or events.
Zone Trigger (Optional)					
Zone shapes	Draw Rectangles and ta	n-and-draw custom shar	nes		
Channels	Create zone areas on ar	y analog channel simult	aneously.		
Number of Areas	Supports up to 50 uniqu	e zone areas and suppo	rting Boolean logic.		
Zone Trigger Conditions			t be "In", "Out", or "Don't Ca		
Boolean Logic Equation Visual Status indicators	Build special custom log	jic trigger equations ie. (<i>F</i>	A1 and not A2) or (A3 and I-time status LED indicat	1 A4) toro Know if the trigger	is weiting processed
Visual Status il fulcators			meaning it met all condi		
Zone Troubleshooting	A special Pass-Thru mo	de helps troubleshoot wi	nen triggers aren't occurri		
Zone Save and Recall	Save a special zone Are	a setup file and recall jus	t the zone areas.		
High and Low Speed Serial Proto	col Triggering (Optio	nal)			
		illoscope Features, Opti	ons, and Accessories Ca	atalog for the latest offe	erings on all our
	instruments				
Measurement Tools					
Measurement Functionality	Display up to 12 meas	rement parameters to	gether with statistics in	cluding mean, minimum	n, maximum, standard
			of each parameter is me		
			meters and waveshape of two different parame		
					sed on range setting or
	waveform state.		•		3 3
Measurement Parameters -	Cycles (number of), Cy	cle to Cycle, Delay (fron	n trigger, 50%), ∆ Delay	(50%), Duty Cycle (50%)	, @level), Edges
Horizontal + Jitter	(number of, @level), Fa	III Time (90-10, @levels)), Frequency (50%, @lev Period (50%, @level), A	/el), Half Period (@level Pariod (@layal), Phasa), Hold Time (@level),
	(10-90 @levels) Setur	ak), Number of Folitis, (Mevels) Skew (Meve	els), Slew Rate (@levels)	Time Interval Frror (@	(Wiever), Rise Time
	Time (@level), Width (50%, @level), Δ Width (@	alevel), X(value)@max,	X(value)@min	(wiever), <u>L</u>
Measurement Parameters - Vertical	Amplitude, Base, Level	@X, Maximum, Mean, N	∕ledian, Minimum, Peak∙	-to-Peak, RMS, Std. Dev	
Measurement Parameters - Pulse		90-10, 80-20, @levels), (Overshoot (positive, neg	ative), Rise Time ($1\overline{0}$ -90), 80-20, @levels), Top,
Measurement Parameters - Statistical	Width (50%) Full Width (@ Half Max	(@%) Amplituda Paga	, Peak@MaxPopulation	Maximum Moon Mod	ian Minimum Modo
(on Histograms)	Range, RMS. Std. Devia	ation, Top, X(value)@Pe	ak, Peaks (number of), F	Percentile, Population (abin, total)
4	,	. , , , , , , , , , , , , , , , , , , ,	(//	, , , (- ' /

Trianguina Cratoro	WaveMaster/SDA 8250HD	WaveMaster/SDA 8330HD	WaveMaster/SDA 8500HD	WaveMaster/SDA 8590HD	WaveMaster/SDA 8650HD
Triggering System Modes		pts: Normal, Auto, Sing	le, and Stop		
Sources	Any input channel Aux		dge. Slope and level uni	que to each source (exc	cent line triager)
Coupling	DC. AC. HFRei. LFRei			que to edori ocuroc (exc	sept inte trigger).
Pre-trigger Delay	0 - 100% of memory si	ze (adjustable in 1% inc	rements of 100 ns)	200	
Post-trigger Delay Hold-off	From 2 ns up to 20 s o	r from 1 to 99,999,999	at slower time/div settir	iys	
Trigger and Interpolator Jitter	<0.1 ps rms (typical, so	oftware assisted), 2 ps r			
Internal Trigger Level Range External Trigger Level Range	±3 div from center (typ Aux (±0.4 V); Aux/10 (±				
Maximum Trigger Rate	> 900.000 waveforms/	second (in Sequence M	lode, up to 4 channels)		
Trigger Sensitivity with Edge Trigger	4 div @ ≤ 15 GHz (Pro	Axial inputs), 5 div @ ≤ 1	5 GHz (1.85mm inputs)		
1.85 mm/ProAxial Inputs	3 div @ < 12 GHz ` 1.5 div @ < 3 GHz				
	1.0 div 🖱 < 200 MHz				
Trigger Sensitivity with Edge Trigger	(for DC coupling, ≥ 10 r 2.5 div @ <1 GHz	mV/div, 50 Ω)			
ProBus Inputs	2.5 div @ <1 GHz 2 div @ <1 GHz				
1 10bus inputs	1.5 div @ <500 MHz				
	1 div @ <200 MHz				
	0.9 div @ <10 MHz	unlin a 0 ma)//div. F0 0)			
External Trigger Sensitivity,	(DC, AC, and LFRej cou 3 div @ <2 GHz	ipiirig, ≥∠ mv/uiv, 50 Ω)			
(Edge Trigger)	2.5 div @ <1 GHz 1.5 div @ <500 MHz				
	1.5 div @ <500 MHz 1 div @ <200 MHz				
	0.9 div @ <10 MHz				
NA Trianna English	(DC, AC, and LFRej cou	pling)			
Max. Trigger Frequency, SMART Trigger	2.0 GHz @ ≥10 mV/div (minimum triggerable)	width 200 ne)			
33	(minimal triggerable	Width 200 p3)			
Trigger Types Edge	Triggers when signal n	neets slone (nositive ne	egative or either) and lev	rel condition	· · · · · · · · · · · · · · · · · · ·
Width	Triggers on positive, ne	egative or both widths (widths selectable as lov	v as 200 ps to 20 s) or c	on intermittent faults.
Glitch	Triggers on positive or	negative glitches (width	ns selectable as low as	200 ps to 20 s) or on in	termittent faults.
Window Pattern	Logic combination (AN	D. NAND. OR. NOR) of 5	y adjustable thresholds inputs (4 channels and	external trigger input).	Fach source can be
	high low or don't care	The high and low level o	can be selected indepen	dently Triggers at start	or end of the pattern
Runt Slew Rate	Trigger on positive or n	egative runts defined by Select limits for dV dt a	two voltage limits and t and slope. Select edge lin	wo time limits. Select be	etween 1 ns and 20 ns.
Interval	Triggers on intervals se	electable between 1 ns	and 20 s.	Tills between This and a	20113.
Dropout	Triggers if signal drops	out for longer than sel	ected time between 1 n	s and 20 s.	and the contract of the contra
Exclusion Triggering Measurement Trigger	Select from a large nur	taults by specifying the	e expected behavior and	triggering when that co	th qualified limits. Can
	he used as only trigger	or last event in a Casca	ade Trigger		·
Multi-Stage: Qualified	Triggers on any input s sources is selectable b	ource only if a defined :	state or edge occurred o	on another input source	e. Holdoff between
Multi-Stage: Qualified First	In Sequence acquisitio	n mode, triggers repeat	ably on event B only if a	defined pattern, state of	or edge (event A) is
	satisfied in the first sec	gment of the acquisition	n. Holdoff between sou	rces is selectable by tim	ne or events.
Zone Trigger (Optional)					
Zone shapes Channels		p-and-draw custom shap y analog channel simulta			
Number of Areas		e zone areas and suppoi			
Zone Trigger Conditions	Each Area condition is s	et as the waveform mus	t be "In", "Out", or "Don't C		
Boolean Logic Equation Visual Status indicators	Each created area and	jic trigger equations ie. (A the descriptor have real	A1 and not A2) or (A3 and I-time status LED indicat	ors Know if the trigger	is waiting processed
	and failed to meet zone	e conditions or passed,	meaning it met all condi	tions and was displayed	
Zone Troubleshooting Zone Save and Recall		de helps troubleshoot wh a setup file and recall jus	nen triggers aren't occurri	ng.	
ZOI le Save ai lu Necali	Save a Special Zone Area	a setup nie and recail jus	t ti le 2011e di eds.		
High- and Low-speed Serial Prot	ocol Triggering (Option	onal)			
	Please refer to the Osc instruments.	illoscope Features, Opti	ons and Accessories Ca	talog for the latest offer	rings on all our
	instruments.				
Measurement Tools Measurement Functionality	Dieplay up to 12 mage	romant parameters to	gether with statistics inc	oludina moon, minimum	maximum etandard
Measurement Functionality			of each parameter is me		
	Histicons provide a fas	t, dynamic view of para	meters and waveshape	characteristics. Param	eter math allows
	measurement on the s	iuitipiication or division ource waveform. Paran	i of two different parami neter accept criteria def	eters. Parameter gates ine allowable values ba	sed on range setting or
	waveform state.		•		9 9
Measurement Parameters -	Cycles (number of), Cy	cle to Cycle, Delay (fron	n trigger, 50%), ∆ Delay), Frequency (50%, @lev	(50%), Duty Cycle (50% (al) Half Pariod (@level)	, @level), Edges
Horizontal + Jitter	N Cvcle Jitter (peak-pe	ak). Number of Points.	period (50%, @level), Δ	Period (@level). Phase ((@level). Rise Time
	(10-90, @levels), Setup	(@levels), Skew (@leve	els), Slew Rate (@levels)	ı, Time Interval Error (@	level), Time (@level), Δ
Measurement Parameters - Vertical	Amplitude Base Level	ου%, (ωιενει), Δ Width ((α ωχ Maximum Mean N	ລlével), X(value)@max, ນີ້ Median, Minimum, Peak	r(value)@MIN to-Peak RMS Std Devi	iation Top
Measurement Parameters - Pulse	Area, Base, Fall Time (9	90-10, 80-20, @levels), (Overshoot (positive, neg	ative), Rise Time (10-90), 80-20, @levels), Top,
Measurement Parameters - Statistical	Width (50%)	(@%) Amplitude Peee	, Peak@MaxPopulation,	Maximum Moon Mod	ian Minimum Mada
(on Histograms)	Range, RMS, Std. Devia	., പ്ര <i>രു,</i> Ampiltude, Base ation, Top, X(value)@Pe	, Peak@MaxPopulation, ak, Peaks (number of), I	Percentile, Population (an, willing lun, wode, @bin, total)
(5.1.1.0009.0.710)	-	, , , ,	, "		35

Marak Tarak	WaveMaster/SDA WaveMaster/SDA WaveMaster/SDA WaveMaster/SDA 8060HD 8080HD 8130HD 8160HD 8200HD
Math Tools Math Functionality	Display up to 12 math functions traces (F1-F12). The easy-to-use graphical interface simplifies set up of up to two
Math Operators - Basic Math	operations on each function trace, and function traces can be chained together to perform math-on-math. Average (summed), Average (continuous), Difference (–), Envelope, Floor, Invert (negate), Product (x), Ratio (/), Reciprocal, Rescale (with units), Roof, Sum (+)
Math Operators - Digital (incl. with MSO options)	Digital AND, Digital DFlipFlop, Digital NAND, Digital NOR, Digital NOT, Digital OR, Digital XOR
Math Operators - Filters Math Operators - Frequency Analysis	Enhanced resolution (to 15 bits vertical), Interpolate (cubic, quadratic, sinx/x) FFT (power spectrum, magnitude, phase, power density, real, imaginary, magnitude squared) up to full analysis
Math Operators - Functions	memory length. Select from Rectangular, VonHann, Hamming, FlatTop and Blackman Harris windows. Absolute value, Correlation (two waveforms), Derivative, Deskew (resample), Exp (base e), Exp (base 10), Integral,
Math Operators - Other	Invert (negate), Log (base e), Log (base 10), Reciprocal, Rescale (with units), Square, Square root, Zoom (identity) Segment, Sparse
Measurement and Math Integrati	
model of the man	Histograms to display statistical distributions of up to 2 billion measurement parameters. Trend (datalog) of up to 1 million measurement parameters. Track (display parameter vs. time, time-correlated to acquisitions) any
	parameter. Persistence histogram and persistence trace (mean, range, sigma).
Pass/Fail Testing	Display up to 12 Pass/Fail gueries using a Single or Dual Parameter Comparison (compare All values, or Any value
	$\langle \cdot, \cdot \rangle$, $\langle \cdot, \cdot \rangle$, within limit $\pm \Delta$ value or $\langle \cdot \rangle$ or Mask Test (pre-defined or user-defined mask, waveform All In, All Out, Any In, or Any Out conditions). Combine queries into a boolean expression to Pass or Fail IF "All True", "All False", "Any True", "Any False", or groups of "All" or "Any", with following THEN Save (waveforms), Stop, Alarm, (send) Pulse,
Display System	Hardcopy (send email, save screen image, save to clipboard, send to printer), or (save) LabNotebook.
Size	Color 15.6" widescreen capacitive touch screen
Resolution Number of Traces	1920 x 1080 pixels Display a maximum of 40 traces. Simultaneously display channel, zoom, memory and math traces.
Grid Styles	Auto, Single, Dual, Quad, Octal, X-Y, Single+X-Y, Dual+X-Y, Tandem, Quatro, Twelve, Sixteen
Waveform Representation	Sample dots joined, or sample dots only
Processor/CPU Type	Intel Core i7-12700E or better
System RAM	64 GB
Operating System Real-Time Clock	Microsoft Windows® 10 Date and time displayed with waveform in hardcopy files. SNTP support to synchronize to precision internal clocks.
Connectivity	
Ethernet Port USB Host Ports	Supports 2.5GBaseT Ethernet interface (RJ45 port)
	4 side USB 3.2 Gen2x1 Type-A ports, 2 front panel USB 3.2 Gen1x1 Type-A ports, 1 front panel USB 3.2 Gen1x1 Type-C port support Windows compatible devices
USB Device Port	1 port - USBTMC over USB 3.1 Gen1 Supports IEEE-488.2 (external)
GPIB Port (Optional) External Monitor Port	2 x HDMI, supports up to 4096 x 2304 resolution
	1 x DisplayPort, supports up to 4096 x 2304 resolution
Remote Control Network Communication Standard	Via Microsoft COM Automation, or via LeCroy Remote Command Set VXI-11 or VICP, LXI Class C (v1.2) compliant
Power Requirements	7.1. 1. 6. 1.6.7 E. 1. 61666 6 (1.1.2) 66.1.p.i.a.i.t
Voltage	100-240 VAC (±10%) at 50/60 Hz (±10%)
Nominal Power Consumption Max Power Consumption	750 W / 750 VA 1125 W / 1125 VA 850 W / 850 VA 1250 VA
Environmental	1200 117 1200 111
Temperature (Operating)	+15 °C to +35 °C
Temperature (Non-Operating) Humidity (Operating)	-20 °C to +60 °C 5% to 90% RH (non-condensing) up to +31 °C, upper limit derating to 50% RH (non-condensing) at +40 °C
Humidity (Non-Operating)	5% to 95% RH (non-condensing) as tested per MIL-PRF-28800F
Altitude (Operating) Altitude (Non-Operating)	Up to 10,000 ft (3048 m) at or below +30 °C Up to 40,000 ft (12,192 m)
Random Vibration (Operating)	0.5 grms 5 Hz to 500 Hz, 15 minutes in each of three orthogonal axes
Random Vibration (Non-Operating) Functional Shock	2.4 grms 5 Hz to 500 Hz, 15 minutes in each of three orthogonal axes 20 g peak, half sine, 11 ms pulse, 3 shocks (positive and negative) in each of three orthogonal axes, 18 shocks total
Size and Weight	20 g pedit, frail sine, 11 fra palse, o sinotio (positive di a negative) in eden of tinee of thogonal dices, 10 sinotio total
Dimensions (HWD)	With handles and protective cover: 15" H x 20.75" W x 16.2" D (381 x 527 x 410 mm)
Weight	Without handles and protective cover: 15" H x 17.5" W x 15.8" D (381 x 445 x 400 mm) 48 lbs (21.8 kg)
Certifications	10 100 (£ 1.0 hg)
CE marked for the European Union	Conforms to EN 61326-1 (for EMC); EN 61010-1, EN 61010-2-030 (for Safety); EN 63000 (for RoHS)
UL approved for the USA and Canada	Conforms to UL 61010-1 (3rd Edition), UL 61010-2-030 (2nd Edition) and CSA C22.2 No.61010-1-12
UKCA marked for Great Britain	Conforms to UK SI 2016 No. 1091 (for EMC), UK SI 2016 No. 1101 (for Safety) and UK SI 2012 No. 3032 (for RoHS)
Warranty and Service	
	3-year warranty; calibration recommended annually. Optional service programs include extended warranty, upgrades and calibration services.

	WaveMaster/SDA 8250HD	WaveMaster/SDA 8330HD	WaveMaster/SDA 8500HD	WaveMaster/SDA 8590HD	WaveMaster/SDA 8650HD
Math Tools Math Functionality	Display up to 12 math f	functions traces (F1-F1	2). The easy-to-use gra	phical interface simplifi	es set up of up to two
Math Operators - Basic Math	Average (summed), Ave	erage (continuous), Diff	n traces can be chained erence (-), Envelope, Fl	<u>l together to perform m</u> oor, Invert (negate), Pro	ath-on-math. duct (x), Ratio (/),
Math Operators - Digital	Reciprocal, Rescale (wi	th units), Roof, Sum (+)	ı gital NOR, Digital NOT, D	inital OR Dinital XOR	
(incl. with MSO options)					
Math Operators - Filters Math Operators - Frequency Analysis	FFT (power spectrum,	magnitude, phase, pow	polate (cubic, quadratic, er density, real, imagina	ry, magnitude squared)	up to full analysis
Math Operators - Functions	Absolute value, Correla	tion (two waveforms),	<u> Hann, Hamming, FlatTo</u> Derivative, Deskew (resa	imple), Exp (base e), Ex	p (base 10), Integral,
Math Operators - Other	Segment, Sparse	ise e), Log (base TU), Ri	eciprocal, Rescale (with	units), Square, Square r	oot, Zoom (Identity)
Measurement and Math Integrat					
December 11 Teachers	to 1 million measureme	ent parameters. Track	of up to 2 billion measu (display parameter vs. ti tence trace (mean, rang	me, time-correlated to a	end (datalog) of up acquisitions) any
Pass/Fail Testing	Dienlay up to 12 Page/	-ail gueries using a Sin	gle or Dual Parameter C	omnarison (compare A	ll values or Any value
	<, <, =, >, ≥, within limit : In, or Any Out condition True", "Any False", or gr	±∆ value or %) or Mask as). Combine queries in oups of "All" or "Any", wi	Test (pre-defined or use to a boolean expression th following THEN Save re to clipboard, send to p	er-defined mask, wavefo to Pass or Fail IF "All Ti (waveforms), Stop, Ala	orm All In, All Out, Any rue", "All False", "Any rm, (send) Pulse,
Display System Size	Color 15.6" widescreen	canacitive touch scree	in .		
Resolution	1920 x 1080 pixels	capacitive touch scree	11		
Number of Traces	Display a maximum of	40 traces. Simultaneou	ısly display channel, zoo	m, memory and math t	races.
Grid Styles Waveform Representation	Auto, Single, Dual, Quad Sample dots joined, or		Dual+X-Y, Tandem, Qua	itro, Twelve, Sixteen	
Processor/CPU	Sample dots joined, or	sample dots only			
Type	Intel Core i7-12700E or	better			
System RAM	64 GB	٦			
Operating System Real-Time Clock	Microsoft Windows® 10 Date and time displayed		copy files. SNTP suppor	t to synchronize to prec	ision internal clocks.
Connectivity Ethernet Port	Supports 2.5GBaseT E	thernet interface (R M5	nort)		
USB Host Ports	4 side USB 3.2 Gen2x1 Type-C port support W	Type-A ports, 2 front p	anel USB 3.2 Gen1x1 Ty	pe-A ports, 1 front pane	el USB 3.2 Gen1x1
USB Device Port	1 port - USBTMC over l	JSB 3.1 Gen1			
GPIB Port (Optional) External Monitor Port	Supports IEEE-488.2 (2 x HDMI, supports up	to 4096 x 2304 resoluti			
Remote Control	1 x DisplayPort, suppor	ts up to 4096 x 2304 re	esolution Remote Command Set		
Network Communication Standard	VXI-11 or VICP, LXI Clas	ss C (v1.2) compliant	Remote Command Set		
Power Requirements	100 040 \ /4 0 / (100)	E0/60 1 (100)			
Voltage Nominal Power Consumption	100-240 VAC (±10%) at 1125 W /			1175 W / 1175 VA	
Max Power Consumption	1250 W /			1300 W / 1300 VA	
Environmental					
Temperature (Operating)	+15 °C to +35 °C				
Temperature (Non-Operating)	-20 °C to +60 °C				\
Humidity (Operating) Humidity (Non-Operating)	5% to 90% RH (non-cor 5% to 95% RH (non-cor	ndensing) up to +31 °C,	upper limit derating to \$	50% RH (non-condensin	ig) at +40 °C
Altitude (Operating)	Up to 10.000 ft (3048 n	n) at or below +30 °C	WILL I IVI 200001		
Altitude (Non-Operating)	Up to 40,000 ft (12,192	m)			
Random Vibration (Operating) Random Vibration (Non-Operating)	0.5 grms 5 Hz to 500 H	Iz, 15 minutes in each o	f three orthogonal axes of three orthogonal axes		
Functional Shock			re and negative) in each of		8 shocks total
Size and Weight				`	
Dimensions (HWD)			75" W x 16.2" D (381 x 5		
Weight	Without handles and pil 48 lbs (2	21.8 kg)	17.5" W x 15.8" D (381 >	53 lbs (24.0 kg)	
Certifications					
CE marked for the European Union UL approved for the USA and Canada UKCA marked for Great Britain	Conforms to UL 61010	-1 (3rd Edition), UL 610	1-1, EN 61010-2-030 (for 10-2-030 (2nd Edition) a JK SI 2016 No. 1101 (fo	and CŚÁ C22.2 No.6101	0-1-12
Warranty and Service					
waitanty and Service	3-year warranty; calibration		nually. Optional service p	programs include exten	ded warranty,

ORDERING INFORMATION

Product Description	Product Code	Product Description	Product Code
WaveMaster 8000HD Oscilloscopes		Cross-layer Analysis Software	
65 GHz, 12 bits, 320 GS/s, 400 Mpts/Ch High Definition Oscilloscope.	WaveMaster 8650HD	synchronization for WaveMaster/SDA	ID-CROSSSYNC-PHY-PCIE
Also operates in 33 GHz 160 GS/s with 200 Mpts/Ch 59 GHz, 12 bits, 320 GS/s, 400 Mpts/Ch	WaveMaster 8590HD		HD-CROSSSYNC-PHY-USB
High Definition Oscilloscope. Also operates in 33 GHz 160 GS/s with 200 Mpts/Ch		synchronization for WaveMaster/SDA 8000HD	
50 GHz, 12 bits, 320 GS/s, 400 Mpts/Ch	WaveMaster 8500HD		
High Definition Oscilloscope. Also operates in 33 GHz 160 GS/s with 200 Mpts/Ch		Serial Data and CrossTalk Analysis SDA Expert single lane eye, noise and jitter analysis for	WM8KHD-SDAX-NRZ
33 GHz, 12 bits, 160 GS/s, 200 Mpts/Ch High Definition Oscilloscope	WaveMaster 8330HD	NRZ signals SDA Expert single lane eye, noise and jitter analysis for	WM8KHD-SDAX-PAM
25 GHz. 12 bits. 160 GS/s. 200 Mpts/Ch	WaveMaster 8250HD	PAM3 and PAM4 signals	
High Definition Oscilloscope 20 GHz, 12 bits, 160 GS/s, 200 Mpts/Ch	WaveMaster 8200HD	for NRZ, PAM3, PAM4 signals. Includes integrated	M8KHD-SDAX-COMPLETE
High Definition Oscilloscope 16 GHz, 12 bits, 80 GS/s, 200 Mpts/Ch	WaveMaster 8160HD		DA8KHD-SDAX-COMPLETE
High Definition Oscilloscope 13 GHz, 12 bits, 80 GS/s, 200 Mpts/Ch	WaveMaster 8130HD		WM8KHD-SDAX-PCIE-NRZ
High Definition Oscilloscope 8 GHz, 12 bits, 80 GS/s, 200 Mpts/Ch	WaveMaster 8080HD	NRZ PCI Express signals up to 32 GT/s SDA Expert configuration and measurements for PAM4	WM8KHD-SDAX-PCIE6
High Definition Oscilloscope		PCI Express signals up to 64 GT/s	
6 GHz, 12 bits, 80 GS/s, 200 Mpts/Ch High Definition Oscilloscope	WaveMaster 8060HD	SDA Expert configuration and measurements for USB3.2 signals at 5 Gb/s and 10 Gbps	WM8KHD-SDAX-USB3.2
SDA 8000HD Serial Data Analyzers		SDA Expert configuration and measurements for USB4 NRZ signals at 10 Gb/s and 20 Gbps,	WM8KHD-SDAX-USB4-TBT
SDA 8000HD Serial Data Analyzers 65 GHz, 12 bits, 320 GS/s, 1000 Mpts/Ch	SDA 8650HD	and PAM3 signals at 40 Gb/s	
High Definition Serial Data Analyzer, 8 Gbps serial trigger. Also operates in 33 GHz 160 GS/s 4Ch mode		SDA Expert configuration and measurements for DisplayPort 1.4 and DisplayPort 2.x signals	WM8KHD-SDAX-DP
with 500 Mpts/Ch 59 GHz, 12 bits, 320 GS/s, 1000 Mpts/Ch	SDA 8590HD	from 1.62 - 20 Gbps	
High Definition Serial Data Analyzer, 8 Gbps serial trigger.	057,100301.15	Signal Integrity Toolkits Advanced De-embedding, Emulation and	
Also operates in 33 GHz 160 GS/s 4Ch mode with 500 Mpts/Ch		Advanced De-embedding, Emulation and Virtual Probing Toolkit	WM8KHD-VIRTUALPROBE
50 GHz, 12 bits, 320 GS/s, 1000 Mpts/Ch	SDA 8500HD	Signal Integrity Toolkit - Channel & Fixture	WM8KHD-EYEDRII
High Definition Serial Data Analyzer, 8 Gbps serial trigger. Also operates in 33 GHz 160 GS/s 4Ch mode		De-embedding/Emulation, Tx/Rx Equalization Cable De-embedding Option	WM8KHD-CBL-DE-EMBED
with 500 Mpts/Ch 33 GHz, 12 bits, 160 GS/s, 500 Mpts/Ch	SDA 8330HD	Modulated Signal Analysis	
High Definition Serial Data Analyzer, 8 Gbps serial trigger 25 GHz, 12 bits, 160 GS/s, 500 Mpts/Ch	SDA 8250HD	VectorLinQ – Flexible vector signal analysis for	WM8KHD-VECTORLINQ
High Definition Serial Data Analyzer, 8 Gbps serial trigger		electrical signals (RF and baseband I-Q) VectorLinQ – Advanced vector signal analysis, W	M8KHD-VECTORLINQ-ADV
20 GHz, 12 bits, 160 GS/s, 500 Mpts/Ch High Definition Serial Data Analyzer, 8 Gbps serial trigger	SDA 8200HD	includes OFDM	Mora is represented the
High Definition Serial Data Analyzer, 8 Gbps serial trigger 16 GHz, 12 bits, 80 GS/s, 500 Mpts/Ch	SDA 8160HD	Ethernet and DDR Debug Tookits	
High Definition Serial Data Analyzer, 8 Gbps serial trigger 13 GHz, 12 bits, 80 GS/s, 500 Mpts/Ch	SDA 8130HD	100Base-T1 and 1000Base-T1 Debug Toolkit WM8 DDR2 and LPDDR2 Debug Toolkit	KHD-AUTO-ENET-TOOLKIT WM8KHD-DDR2-TOOLKIT
High Definition Serial Data Analyzer, 8 Gbps serial trigger 8 GHz, 12 bits, 80 GS/s, 500 Mpts/Ch	SDA 8080HD	DDR 2/3 and LPDDR 2/3 Debug Toolkit	WM8KHD-DDR3-TOOLKIT
High Definition Serial Data Analyzer, 8 Gbps serial trigger		DDR 2/3/4 and LPDDR 2/3/4/4X Debug Toolkit DDR 2/3/4/5 and LPDDR 2/3/4/4X Debug Toolkit	WM8KHD-DDR4-TOOLKIT WM8KHD-DDR5-TOOLKIT
6 GHz, 12 bits, 80 GS/s, 500 Mpts/Ch High Definition Serial Data Analyzer, 8 Gbps serial trigger	SDA 8060HD	Serial Data Compliance Test Software	
Included with Standard Configuration		QualiPHY Enabled 1000Base-T1 (Automotive Ethernet)	QPHY-1000BASE-T1
ProAxial - 2.92 mm adapters, Qty. 4: for ≥ 25 GHz models		Software Option QualiPHY Enabled 100Base-T1 (Automotive Ethernet)	QPHY-100BASE-T1
ProLink to K/2.92 mm Adapter, Qty 4: for 20 GHz units ProLink to SMA Adapter, Qty 4: for 6 - 16 GHz units		Software Option OualiPHY Enabled 10Base-T1L (Industrial Ethernet)	QPHY-10Base-T1L
1.85 mm adapters (Otv.2), Universal Wrench, Torque Wrench	: for ≥ 50 GHz models	Compliance Software Option	•
÷10, 500 MHz Passive Probe (Qty. 4) Optical 3-button Wheel Mouse		QualiPHY Enabled 10Base-T1S (Automotive Ethernet) Software Option	QPHY-10BASE-T1S
Protective Front Cover Printed Getting Started Guide		QualiPHY Enabled 10GBase-KR Software Option QualiPHY Enabled 10GBase-T Software Option	QPHY-10GBASE-KR QPHY-10GBASE-T
Anti-virus Software (Trial Version)		QualiPHY Enabled DDR2 Software Option	QPHY-DDR2
Microsoft Windows® 10 License Commercial NIST Traceable Calibration with Certificate		QualiPHY Enabled DDR3, DDR3L and LPDDR3 Software QualiPHY Enabled DDR4 and LPDDR4/4X Software Opt	
Power Cable for the Destination Country		QualiPHY DDR5 System Level Automated Compliance	QPHY-DDR5-SYS
3-year Warranty		Software Option DDR5 Bundle including QualiPHY and DDR Debug	WM8KHD-DDR5-BUNDLE
Mixed Signal Solutions 2.5 GS/s Internal Mixed Signal Option for WaveMaster/	WM8KHD-MS0	Toolkit for DDR2/3/4/5 and LPDDR 2/3/4/4X	
SDA 8000HD (includes probe, accessories, and license) 12.5 GS/s High-speed Digital Analyzer with 18ch Quick-	HDA125-18-LBUS	QualiPHY Enabled DisplayPort 2.0 Sink Compliance Software Option	QPHY-DP2-SINK
Link leadset and LBUS connection		QualiPHY Enabled DisplayPort 2.0 Source Compliance Software Option (Includes QPHY-DP14-SOURCE)	QPHY-DP2-SOURCE
12.5 GS/s High-speed Digital Analyzer with 9ch QuickLink leadset and LBUS connection	HDA125-09-LBUS	QualiPHY Enabled Embedded DisplayPort Software Op QualiPHY Enabled Ethernet 10/100/1000BT Software Op	otion QPHY-eDP Option QPHY-ENET*
Memory and Sample Rate Options		QualiPHY Enabled HDMI 2.1 FRL and TMDS Software C	option QPHY-HDMI21**
500 Mpt memory option for WaveMaster 8000HD	WM8KHD-500MPT	QualiPHY Enabled MIPI C-PHY Software Option QualiPHY Enabled MIPI D-PHY Software Option	QPHY-MIPI-CPHY QPHY-MIPI-DPHY
(standard on SDA 8000HD) 2 Gpt memory option for WaveMaster 8000HD	WM8KHD-2000MPT	QualiPHY Enabled MIPI M-PHY Software Option	QPHY-MIPI-MPHY
8 Gpt memory option for WaveMaster 8000HD 2 Gpt memory option for SDA 8000HD	WM8KHD-8000MPT SDA8KHD-2000MPT	QualiPHY Enabled MultiGBase-T1 (Automotive Etherne Compliance Software Option	t) QPHY-MultiGBase-T1
8 Gpt memory option for SDA 8000HD	SDA8KHD-2000MPT	*TF-ENET-B required. [†] TF-HDMI-3.3V-QUADPAK require	od İTE-LISB-B roquirod
CPU, Computer and Other Hardware Options		*TF-ENET-B required. *TF-HDMI-3.3V-QUADPAK required. **TF-HDMI-3.3V-QUADPAK required.	a. c ir-oob-b lequilea.
Additional Removable Solid State Drive for WaveMaster/SDA 8000HD	WM8KHD-RSSD-02		
Wavelviaster/SDA 6000HD			

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Product Description	Product Code	Product Description	Product Code
Serial Data Compliance Test Software (Cont'd)		Serial Data Triggers and Decoders(Cont'd)	
QualiPHY NBASE-T (2.5GBase-T and 5 GBase-T)	QPHY-NBASE-T	DisplayPort AUX Trigger and Decode Option DisplayPort AUX Trigger, Decode, Measure/Graph,	WM8KHD-DPAUX TD WM8KHD-DPAUX TDMP
Compliance Software Option QualiPHY Enabled PCIe 1.0/2.0 Software Option	QPHY-PCIE	and Physical Layer Test Option	WINIOR ID DI NOX I DIVII
QualiPHY Enabled PCle 3.0 Tx/Rx Software Option	QPHY-PCIE3-TX-RX	MIPI D-PHY Decode Option	WM8KHD-DPHYbus D
QualiPHY PCle 4.0 Compliance Software Option QualiPHY PCle 5.0 Compliance Software Option	QPHY-PCIE4-TX-RX QPHY-PCIE5-TX-RX	MIPI D-PHY Decode option MIPI D-PHY Decode and Physical Layer Test Option	WM8KHD-DPHYbus DP
OualiPHY 2 PCIe 6.0 Compliance Software Option	OPHY2-PCIE6-TX-RX	I ² C, SPI, UART-RS232 Trigger and Decode Bundle	WM8KHD-EMB TD
QualiPHY Enabled SATA Software Option QualiPHY Enabled SAS-3 Software Option	PHY-SATA-TSG-RSG QPHY-SAS3	I ² C, SPI, UART-RS232 Trigger, Decode, Measure/Graph and Eye Diagram Bundle	WM8KHD-EMB TDME
QualiPHY Enabled SFI Software Option	QPHY-SFI	Ethernet 10G Decode Option	WM8KHD-ENET10Gbus D
QualiPHY Enabled USB 2.0 Software Option QualiPHY Enabled USB 3.2 Tx-Rx Software Option	QPHY-USB‡ QPHY-USB3.2-TX-RX	ENET Decode Option Fibre Channel Decode Option	WM8KHD-ENETbus D WM8KHD-FCbus D
QualiPHY 2 Enabled USB4 Transmitter and Receiver	QPHY2-USB4-TX-RX	FlexRay Trigger and Decode Option	WM8KHD-FlexRayBus TD
Compliance Software Option		FlexRay Trigger, Decode, Measure/Graph WN	18KHD-FLEXRAYBUS TDMP
QualiPHY 2 PC Off-line Compliance Software (Permanent License)	QPHY2-PC	and Physical Layer Option I ² C Bus Trigger and Decode Option	WM8KHD-I2Cbus TD
QualiPHY 2 PC Off-line Compliance Software	QPHY2-PC-1YR	I ² C Trigger, Decode, Measure/Graph, and	WM8KHD-I2CBUS TDME
(1 Year renewable License)		Eye Diagram Option I³C Decode Option	WM8KHD-I3CBUS D
*TF-ENET-B required. [†] TF-HDMI-3.3V-QUADPAK required. [‡] 1	F-USB-B required.	I ³ C Trigger and Decode Option	WM8KHD-I3CBUS TD
**TF-HDMI-3.3V-QUADPAK required.		I ³ C Trigger, Decode, Measure/Graph and Eye Diagram Option	WM8KHD-I3CBUS TDME
Serial Data Test Fixtures		13C Decode, Measure/Graph, and Eye Diagram Option	WM8KHD-I3CBUS DME
Test Fixture for 10GBase-T	TF-10GBASE-T	LIN Trigger and Decode Option	WM8KHD-LINbus TD
USB4 Sideband Test Coupon Fixture USB4 High-speed and Sideband Test Coupon Fixture	TF-USB-C-SB TF-USB-C-HS	LIN Trigger, Decode, Measure/Graph and Eye Diagram Option	WM8KHD-LINBUS TDME
Automotive Ethernet Breakout Test Fixture for	TF-AUTO-ENET	Manchester Decode Option V	WM8KHD-Manchesterbus D
100Base-T1 and 1000Base-T1 Debug Test Fixture HMTD-Connector (m) to SMA (f)	TF-AUTO-HMTD	MDIO Decode MIPI M-PHY Decode Option	WM8KHD-MDIObus D WM8KHD-MPHYbus D
Test Fixture MATEnet-Connector (m) to SMA (f)	TF-AUTO-MATENET	MIPI M-PHY Decode and Physical Layer Test Option	WM8KHD-MPHYbus DP
	TF-AUTO-ENET-SMA	PCI Express 5.0 to 1.0 Link Layer Decode Option	WM8KHD-PCIEbus D
10/100/1000Base-T Ethernet Test Fixture HDMI Pull-Up Terminator Quad Pack TF-I	TF-ENET-B* HDMI-3.3V-QUADPAK	PCI Express 6.0 to 1.0 Link Layer Decode Option Decoder-Protocol Analyzer Synchronization	WM8KHD-PCIE6BUS D WM8KHD-ProtoSync
SATA 1.5 Gb/s. 3.0 Gb/s and 6.0 Gb/s	TF-SATA-C-KIT	Software Option	
Compliance Test Fixture Measure Kit USB 2.0 Compliance Test Fixture	TF-USB-B	Decoder-Protocol Analyzer Synchronization with Bit Tracer Software Option	WM8KHD-ProtoSync-BT
USB 3.0 and 3.1 Compliance Test Fixture	TF-USB3	PMBus Trigger, Decode, Measure/Graph, and	WM8KHD-PMBUS TDME
Electrical Telecom Pulse Mask Test Package MIPI M-PHY input offset adapter dual pack Test Fixture Kit for NBase-T and 10GBase-T	WM8KHD-ET-PMT MIPI-MPHY-DUALPAK TF-NBASE-T	Eye Diagram Option QSPI (Simple Data, Dual-, Quad-SPI) Trigger and	WM8KHD-QSPI TD
*Includes ENET-2CAB-SMA018 and ENET-2ADA-BNCSMA	II NDAGE I	Decode Option SAS Decode Annotation Option	WM8KHD-SASbus D
		SATA Decode Annotation Option	WM8KHD-SATAbus D
High-speed Serial Triggers and Decoders 80-bit NRZ, 8b/10b, and 64b/66b 8 Gbps WM8KH	D-8GBIT-SYMBOL-TD	SENT Trigger and Decode Option SENT Trigger, Decode, Measure/Graph, and	WM8KHD-SENTbus TD WM8KHD-SENTbus TDME
Serial Trigger option for WaveMaster	D-0GB11-31WB0L-1D	Eye Diagram Option	
models 80-bit NRZ, 8b/10b, and 64b/66b 16 Gbps WM8KHD	-16GBIT-SYMBOL-TD	SMBUS Trigger and Decode Option SMBUS Trigger, Decode, Measure/Graph, and	WM8KHD-SMBUS TD WM8KHD-SMBUS TDME
Serial Trigger option for WaveMaster	-100B11-21MB0F-1D	Eye Diagram Option	
models	1100170141001 70	SpaceWire Decode Option V SPI Trigger and Decode Option	WM8KHD-SpaceWirebus TD WM8KHD-SPIbus TD
80-bit NRZ, 8b/10b, and 64b/66b 16 Gbps SDA8KHD-UPG Serial Trigger upgrade for SDA model	G-16GBIT-SYMBOL-TD	SPI Trigger, Decode, Measure/Graph, and	WM8KHD-SPIBUS TDME
		Eye Diagram Option SPMI Trigger and Decode Option	WM8KHD-SPMIbus TD
Serial Data Triggers and Decoders 1000Base-T1 Trigger and Decode Option WM8k	(HD-1000Base-T1 TD	SPMI Trigger, Decode, Measure/Graph, and	WM8KHD-SPMIbus TDME
1000Base-T1 Trigger, Decode, Measure/Graph WM8KHD	-1000Base-T1 TDME	Eye Diagram Option SPMI Decode Option	WM8KHD-SPMIBUS D
and Eye Diagram Option 100Base-T1 Trigger and Decode Option WM8KHI	D-100Base-T1bus TD	UART and RS-232 Trigger and Decode Option WI	M8KHD-UART-RS232bus TD
100Base-T1 Trigger, Decode, Measure/Graph, WM8KH	D-100Base-T1 TDMP	UART-RS232 Trigger, Decode, WM8k Measure/Graph and Eye Diagram Option	KHD-UART-RS232BUS TDME
and Physical Layer Test Option 10Base-T1S Trigger, Decode, Measure/Graph, WM8KHI	D-10BASE-T1S TDME	MIPI UniPro Protocol Decoder	WM8KHD-UNIPRObus D
and Eye Diagram Option		USB-PD Power Delivery Trigger and Decode Option USB-PD Power Delivery Trigger, Decode, Measure/	WM8KHD-USBPD TD WM8KHD-USBPD TDMP
10Base-T1S Trigger and Decode Option WM8I MIL-STD-1553 Trigger and Decode Option	KHD-10BASE-T1S TD WM8KHD-1553 TD	Graph and Physical Layer Test Option	
MIL-STD-1553 Trigger, Decode, Measure/Graph, and W	VM8KHD-1553 TDME	USB2-HSIC Decode Option USB4-SB Trigger and Decode Option	WM8KHD-USB2-HSICbus D WM8KHD-USB4SB TD
Eye Diagram Option	WWW.	USB4 Decode, Measure/Graph, and Eve	WM8KHD-USB4BUS DME
64b/66b Decode Option 8b10b Decode Option	WM8KHD-64b66b D WM8KHD-8B10B D	Measurements Option USB4-SB Trigger, Decode, Measure/Graph, and	WM8KHD-USB4SB TDMP
ARINC 429 Bus Symbolic Decode, WM8KHD-ARINC429 Measure/Graph, Eye Diagram Option	BUS DME SYMBOLIC	PHY Meas. Option	
ARINC 429 Bus Symbolic Decode Option WM8KHD-ARIN	C429bus DSymbolic	USB 2.0 Trigger and Decode Option USB 2.0 Trigger, Decode, Measure/Graph, and	WM8KHD-USB2bus TD WM8KHD-USB2bus TDME
Trigger and Decode Option for WM I2S, LJ, RJ, and TDM	8KHD-AUDIOBUS TD	Eye Diagram Option	
	KHD-AUDIOBUS TDG	USB 3.2 Decode Option	WM8KHD-USB32BUS D
CAN FD Trigger and Decode Option WM8	BKHD-CAN FDbus TD		
CAN/CAN FD Symbolic Trigger, WM8KHD-CAN FDB Decode, Measure/Graph, and Eye	US TDME SYMBOLIC		
Diagram Option			
CAN/CAN FD/CAN XL Trigger and Decode Option CAN Trigger and Decode Option WM8KHD-CAN	WM8KHD-CAN XL TD XL TDME SYMBOLIC		
C-PHY (DSI-2/CSI-2) Decode Option W	M8KHD-CPHYBUS D		
C-PHY (DSI-2/CSI-2) Decode, Measure/ WM8 Graph and Physical Layer Test Option	KHD-CPHYBUS DMP		
DigRF 3G Decode Option WM	8KHD-DigRF3Gbus D		
DigRF v4 Decode Option WM	8KHD-DigRFV4bus D		_

ORDERING INFORMATION

Product Description Product Code	Product Description Product Code
Remote Control/Network Options	Probes and Probe Accessories (Cont'd)
USB to GPIB adapter for GPIB Device Ability USB2-GPIB	25 MHz High Voltage Differential Probe HVD3102A
USB to GPIB adapter for GPIB Host Ability GPIB-HOST	1 kV, 25 MHz High Voltage Differential Probe HVD3102A-NOACC
	(without tip accessories)
Jitter Analysis Software	120 MHz High Voltage Differential Probe HVD3106A
Clock Expert Jitter Analysis Framework WR8KHD-CLOCK-X	1 kV, 120 MHz High Voltage Differential Probe HVD3106A-NOACC
Clock Expert Jitter Analysis Framework with SSC, WM8KHD-CLOCK-X-PRO	(without tip accessories)
Phase Noise and Accumulated Jitter Analysis	80 MHz, High Voltage Differential Probe with 6 m Cable HVD3106A-6M
Clock Jitter Analysis with Four Views Software Package WM8KHD-JITKIT	2 kV, 120 MHz High Voltage Differential Probe HVD3206A
,	2 kV, 80 MHz High Voltage Differential Probe with 6 m Cable HVD3206A-6M
General Purpose and Application Specific Software Options	2 kV, 400 MHz High Voltage Differential Probe HVD3220
Spectrum Analyzer Option (1 trace) WM8KHD-SPECTRUM-1	6 kV, 100 MHz High Voltage Differential Probe HVD3605A
Spectrum Analyzer Option WM8KHD-SPECTRUM-PRO-2	700 V, 25 MHz High-Voltage Differential Probe AP031
(2 traces + reference trace)	500 MHz Differential Probe AP033
MAUI Studio Pro Software MAUI STUDIO PRO	500 MHz, 1.0 pF Active Differential Probe, ±8 V ZD500
Digital Filter Software Package WM8KHD-DFP2	1 GHz, 1.0 pF Active Differential Probe, ±8 V ZD1000
EMC Pulse Parameter Software Package WM8KHD-EMC	1.5 GHz, 1.0 pF Active Differential Probe, ±8 V ZD1500
Power Analysis Option WM8KHD-PWR	4 GHz ProBus2 Differential Probe w/ Dx10-SI, Dx10-QC, Dx10-SP D410-A-PB2
Power Device Analysis Option WM8KHD-POWER-DEVICE	4 GHz ProBus2 Differential Probe w/ Dx20-SI, Dx20-QC, Dx20-SP D420-A-PB2 GHz ProBus2 Differential Probe w/ Dx10-SI, Dx10-QC, Dx10-SP D610-A-PL
Digital Power Management Analysis Option WM8KHD-DIG-PWR-MGMT	6 GHz ProBus2 Differential Probe w/ Dx20-SI, Dx20-QC, Dx20-SP D620-A-PL
Zone Trigger Option WM8KHD-ZONETRIGGER	4 GHz ProBus2 Differential Probe with Adjustable Tip D400A-AT-PB2
	6 GHz ProLink Differential Probe with Adjustable Tip D400A-AT-PL
General Accessories	Programmable Current Sensor to ProBus Adapter CA10
ProLink to 2.92mm Adapter with Probe Power and LPA-2.92	(for use with third party current sensors)
Communication Pass Through y	30 A, 50 MHz Current Probe - AC/DC, 30 A rms, 50 A Peak Pulse, CP030B
ProLink to K/2.92 mm Adapter LPA-K-A	1.5 meter cable
ProLink to 2.92mm ProAxial Adapter Kit LPA-2.92-PX-KIT Rackmount kit for WaveMaster/SDA 8000HD WM8KHD-RACKMOUNT	30 A. 10 MHz Current Probe - AC/DC, 30 A rms, 50 A Peak Pulse. CP030-3M
Rackmount kit for WaveMaster/SDA 8000HD WM8KHD-RACKMOUNT	3 meter cable
	30 A, 50 MHz High Sensitivity Current Probe - AC/DC, 30 A rms, CP030A
Probes and Probe Accessories	50 A Peak Pulse, 1.5 meter cable
30 GHz differential probe with ProAxial interface DH30-PX	30A, 100 MHz Current Probe - AC/DC, 30 A rms, 50 A Peak Pulse, CP031
25 GHz differential probe with ProAxial interface DH25-PX	1.5 meter cable
20 GHz differential probe with ProLink interface DH20-PL	30 A, 100 MHz High Sensitivity Current Probe - AC/DC, 30 A rms, CP031A
High Voltage Fiber Optic Probe, 150 MHz Bandwidth HVF0108	50 A Peak Pulse, 1.5 meter cable
Power/Voltage Rail Probe. 2 GHz bandwidth, 1.2x RP2060	150 A, 10 MHz Current Probe - AC/DC, 150 A rms, 500 A Peak Pulse, CP150B
attenuation, +/-60V offset, +/-800mV	2 meter cable
Power/Voltage Rail Probe. 4 GHz bandwidth, 1.2x RP4060	150 A, 5 MHz Current Probe - AC/DC, 150 A rms, 500 A Peak Pulse, CP150-6M
attenuation, +/-60V offset, +/-800mV	6 meter cable 500 A. 2 MHz Current Probe - AC/DC. 500 A rms. 700 A Peak Pulse. CP500
High Voltage Optically Isolated Probe, 350 MHz Bandwidth DL03-ISO	6 meter cable
High Voltage Optically Isolated Probe, 700 MHz Bandwidth DL07-ISO	7.5 GHz Low Capacitance Passive Probe (÷10, 1 kΩ; ÷20, 500 Ω) PP066
High Voltage Optically Isolated Probe, 1 GHz Bandwidth DL10-ISO	500 MHz Passive Probe, 2.5mm PP021-1
250 MHz 60 V Common Mode Differential Probe DL02-HCM	500 MHz Passive Probe, 5mm PP025-1
500 MHz 60 V Common Mode Differential Probe 1 GHz 60 V Common Mode Differential Probe DL10-HCM	TekProbe to ProBus Probe Adapter TPA10
	Total Tobo to Trobad Troba Tadpto.
1.0 GHz , 0.9 pF , $1 \text{ M}\Omega$ High Impedance Active ProbeZS1000 1.5 GHz , 0.9 pF , $1 \text{ M}\Omega$ High Impedance Active ProbeZS1500	A variety of other active voltage and current probes are also available.
2.5GHz , 0.9pF , $1 \text{M}\Omega$ High Impedance Active Probe ZS2500	Consult Teledyne LeCroy for more information.
4.0 GHz, 0.6 pF, 1 MΩ High Impedance Active Probe ZS4000	
400 MHz, 1kV Vrvms High-Voltage Passive Probe HVP120	
6kV High Voltage Passive Probe, 500 MHz PPE6KV-A	
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Customer Service
Teledyne LeCroy oscilloscopes and probes are designed, built and tested to ensure high reliability. In the unlikely event you experience difficulties, our digital oscilloscopes are fully warranted for three years and our probes are warranted for one year. This warranty includes:

- No charge for return shipping
- Long-term 7-year support
- Upgrade to latest software at no charge



1-800-5-LeCroy teledynelecroy.com Local sales offices are located throughout the world. Visit our website to find the most convenient location.